## ADSP-21062/ADSP-21062L

## SUMMARY

High Performance Signal Processor for Communications, Graphics and Imaging Applications
Super Harvard Architecture
Four Independent Buses for Dual Data Fetch, Instruction Fetch and Nonintrusive I/O
32-Bit IEEE Floating-Point Computation UnitsMultiplier, ALU, and Shifter
Dual-Ported On-Chip SRAM and Integrated I/O
Peripherals-A Complete System-On-A-Chip
Integrated Multiprocessing Features

## KEY FEATURES

40 MIPS, 25 ns Instruction Rate, Single-Cycle Instruction Execution
120 MFLOPS Peak, 80 MFLOPS Sustained Performance
Dual Data Address Generators with Modulo and BitReverse Addressing
Efficient Program Sequencing with Zero-Overhead Looping: Single-Cycle Loop Setup

IEEE JTAG Standard 1149.1 Test Access Port and On-Chip Emulation
240-Lead Thermally Enhanced MQFP Package
225-Ball Plastic Ball Grid Array (PBGA)
32-Bit Single-Precision and 40-Bit Extended-Precision IEEE Floating-Point Data Formats or 32-Bit FixedPoint Data Format

Parallel Computations
Single-Cycle Multiply and ALU Operations in Parallel with Dual Memory Read/Writes and Instruction Fetch
Multiply with Add and Subtract for Accelerated FFT Butterfly Computation
2 Mbit On-Chip SRAM
Dual-Ported for Independent Access by Core Processor and DMA

Off-Chip Memory Interfacing
4 Gigawords Addressable
Programmable Wait State Generation, Page-Mode DRAM Support


Figure 1. ADSP-21062/ADSP-21062L Block Diagram

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## ADSP-21062/ADSP-21062L

DMA Controller<br>10 DMA Channels for Transfers Between ADSP-21062 Internal Memory and External Memory, External Peripherals, Host Processor, Serial Ports, or Link Ports<br>Background DMA Transfers at 40 MHz, in Parallel with Full-Speed Processor Execution<br>Host Processor Interface to 16- and 32-Bit Microprocessors<br>Host Can Directly Read/Write ADSP-21062 Internal Memory

## Multiprocessing <br> Glueless Connection for Scalable DSP Multiprocessing Architecture <br> Distributed On-Chip Bus Arbitration for Parallel Bus Connect of Up to Six ADSP-21062s Plus Host <br> Six Link Ports for Point-to-Point Connectivity and Array Multiprocessing <br> 240 Mbytes/s Transfer Rate Over Parallel Bus 240 Mbytes/s Transfer Rate Over Link Ports <br> Serial Ports <br> Two 40 Mbit/s Synchronous Serial Ports with Companding Hardware <br> Independent Transmit and Receive Functions

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## ADSP-21062/ADSP-21062L



GENERAL NOTE
This data sheet represents production released specifications for the ADSP-21062 ( 5 V ) and ADSP-21062L (3.3V) processors, for both 33 MHz and 40 MHz speed grades. The product name "ADSP-21062" is used throughout this data sheet to represent all devices, except where expressly noted.

## GENERAL DESCRIPTION

The ADSP-21062 SHARC-Super Harvard Architecture Computer-is a signal processing microcomputer that offers new capabilities and levels of performance. The ADSP-21062 SHARCs are 32-bit processors optimized for high performance DSP applications. The ADSP-21062 builds on the ADSP-21000 DSP core to form a complete system-on-a-chip, adding a dualported on-chip SRAM and integrated I/O peripherals supported by a dedicated I/O bus.
Fabricated in a high speed, low power CMOS process, the ADSP-21062 has a 25 ns instruction cycle time and operates at 40 MIPS. With its on-chip instruction cache, the processor can execute every instruction in a single cycle. Table I shows performance benchmarks for the ADSP-21062.
The ADSP-21062 SHARC represents a new standard of integration for signal computers, combining a high performance floating-point DSP core with integrated, on-chip system features
including a 2 Mbit SRAM memory (4 Mbit on the ADSP-21060), host processor interface, DMA controller, serial ports and link port and parallel bus connectivity for glueless DSP multiprocessing.
Figure 1 shows a block diagram of the ADSP-21062, illustrating the following architectural features:

Computation Units (ALU, Multiplier and Shifter) with a Shared Data Register File
Data Address Generators (DAG1, DAG2)
Program Sequencer with Instruction Cache
Interval Timer
On-Chip SRAM
External Port for Interfacing to Off-Chip Memory and Peripherals
Host Port and Multiprocessor Interface
DMA Controller
Serial Ports and Link Ports
JTAG Test Access Port
Figure 2 shows a typical single-processor system. A multiprocessing system is shown in Figure 3.

Table I. ADSP-21062/ADSP-21062L Benchmarks (@ 40 MHz )

| 1024-Pt. Complex FFT | 0.46 ms | 18,221 cycles |
| :--- | :--- | :--- |
| $\quad$ (Radix 4, with Digit Reverse) |  |  |
| FIR Filter (per Tap) | 25 ns | 1 cycle |
| IIR Filter (per Biquad) | 100 ns | 4 cycles |
| Divide (y/x) | 150 ns | 6 cycles |
| Inverse Square Root (1/ $\sqrt{\mathrm{x})}$ | 225 ns | 9 cycles |
| DMA Transfer Rate | $240 \mathrm{Mbytes} / \mathrm{s}$ |  |

## ADSP-21062/ADSP-21062L

## ADSP-21000 FAMILY CORE ARCHITECTURE

The ADSP-21062 includes the following architectural features of the ADSP-21000 family core. The ADSP-21062 processors are code- and function-compatible with the ADSP-21020.

## Independent, Parallel Computation Units

The arithmetic/logic unit (ALU), multiplier and shifter all perform single-cycle instructions. The three units are arranged in parallel, maximizing computational throughput. Single multifunction instructions execute parallel ALU and multiplier operations. These computation units support IEEE 32-bit singleprecision floating-point, extended precision 40-bit floatingpoint, and 32-bit fixed-point data formats.


Figure 2. ADSP-21062 System

## Data Register File

A general purpose data register file is used for transferring data between the computation units and the data buses, and for storing intermediate results. This 10 -port, 32 -register ( 16 primary, 16 secondary) register file, combined with the ADSP21000 Harvard architecture, allows unconstrained data flow between computation units and internal memory.

## Single-Cycle Fetch of Instruction and Two Operands

The ADSP-21062 features an enhanced Harvard architecture in which the data memory (DM) bus transfers data and the program memory (PM) bus transfers both instructions and data (see Figure 1). With its separate program and data memory buses and on-chip instruction cache, the processor can simultaneously fetch two operands and an instruction (from the cache), all in a single cycle.

## Instruction Cache

The ADSP-21062 includes an on-chip instruction cache that enables three-bus operation for fetching an instruction and two data values. The cache is selective-only the instructions whose fetches conflict with PM bus data accesses are cached. This allows full-speed execution of core, looped operations such as digital filter multiply-accumulates and FFT butterfly processing.

## Data Address Generators with Hardware Circular Buffers

 The ADSP-21062's two data address generators (DAGs) implement circular data buffers in hardware. Circular buffers allow efficient programming of delay lines and other data structures required in digital signal processing, and are commonly used in digital filters and Fourier transforms. The two DAGs of the ADSP-21062 contain sufficient registers to allow the creation of up to 32 circular buffers ( 16 primary register sets, 16 secondary). The DAGs automatically handle address pointer wraparound, reducing overhead, increasing performance and simplifying implementation. Circular buffers can start and end at any memory location.
## Flexible Instruction Set

The 48-bit instruction word accommodates a variety of parallel operations, for concise programming. For example, the ADSP21062 can conditionally execute a multiply, an add, a subtract and a branch, all in a single instruction.

## ADSP-21062/ADSP-21062L FEATURES

Augmenting the ADSP-21000 family core, the ADSP-21062 adds the following architectural features:

## Dual-Ported On-Chip Memory

The ADSP-21062 contains two megabits of on-chip SRAM, organized as two blocks of 1 Mbits each, which can be configured for different combinations of code and data storage. Each memory block is dual-ported for single-cycle, independent accesses by the core processor and I/O processor or DMA controller. The dual-ported memory and separate on-chip buses allow two data transfers from the core and one from I/O, all in a single cycle.
On the ADSP-21062, the memory can be configured as a maximum of 64 K words of 32 -bit data, 128 K words of 16 -bit data, 40 K words of 48 -bit instructions (or 40 -bit data), or combinations of different word sizes up to two megabits. All of the memory can be accessed as 16 -bit, 32 -bit or 48 -bit words.
A 16-bit floating-point storage format is supported, which effectively doubles the amount of data that may be stored on-chip. Conversion between the 32-bit floating-point and 16-bit floatingpoint formats is done in a single instruction.
While each memory block can store combinations of code and data, accesses are most efficient when one block stores data, using the DM bus for transfers, and the other block stores instructions and data, using the PM bus for transfers. Using the DM bus and PM bus in this way, with one dedicated to each memory block, assures single-cycle execution with two data transfers. In this case, the instruction must be available in the cache. Single-cycle execution is also maintained when one of the data operands is transferred to or from off-chip, via the ADSP21062's external port.

## Off-Chip Memory and Peripherals Interface

The ADSP-21062's external port provides the processor's interface to off-chip memory and peripherals. The 4 -gigaword offchip address space is included in the ADSP-21062's unified address space. The separate on-chip buses-for PM addresses, PM data, DM addresses, DM data, I/O addresses and I/O data-are multiplexed at the external port to create an external system bus with a single 32-bit address bus and a single 48-bit (or 32-bit) data bus.
Addressing of external memory devices is facilitated by on-chip decoding of high-order address lines to generate memory bank select signals. Separate control lines are also generated for simplified addressing of page-mode DRAM. The ADSP-21062 provides programmable memory wait states and external memory acknowledge controls to allow interfacing to DRAM and peripherals with variable access, hold and disable time requirements.

## Host Processor Interface

The ADSP-21062's host interface allows easy connection to standard microprocessor buses, both 16-bit and 32-bit, with little additional hardware required. Asynchronous transfers at speeds up to the full clock rate of the processor are supported. The host interface is accessed through the ADSP-21062's external port and is memory-mapped into the unified address space. Four channels of DMA are available for the host interface; code and data transfers are accomplished with low software overhead.
The host processor requests the ADSP-21062's external bus with the host bus request $(\overline{\mathrm{HBR}})$, host bus grant $(\overline{\mathrm{HBG}})$, and ready (REDY) signals. The host can directly read and write the internal memory of the ADSP-21062, and can access the DMA channel setup and mailbox registers. Vector interrupt support is provided for efficient execution of host commands.

## DMA Controller

The ADSP-21062's on-chip DMA controller allows zerooverhead data transfers without processor intervention. The DMA controller operates independently and invisibly to the processor core, allowing DMA operations to occur while the core is simultaneously executing its program instructions.
DMA transfers can occur between the ADSP-21062's internal memory and either external memory, external peripherals or a host processor. DMA transfers can also occur between the ADSP-21062's internal memory and its serial ports or link ports. DMA transfers between external memory and external peripheral devices are another option. External bus packing to $16-$, 32 -, or 48 -bit words is performed during DMA transfers.
Ten channels of DMA are available on the ADSP-21062-two via the link ports, four via the serial ports, and four via the processor's external port (for either host processor, other ADSP-21062s, memory or I/O transfers). Four additional link port DMA channels are shared with serial port 1 and the external port. Programs can be downloaded to the ADSP21062 using DMA transfers. Asynchronous off-chip peripherals can control two DMA channels using DMA Request/ Grant lines ( $\overline{\text { DMAR1-2 }}, \overline{\text { DMAG1- }}$ ). Other DMA features
include interrupt generation upon completion of DMA transfers and DMA chaining for automatic linked DMA transfers.

## Serial Ports

The ADSP-21062 features two synchronous serial ports that provide an inexpensive interface to a wide variety of digital and mixed-signal peripheral devices. The serial ports can operate at the full clock rate of the processor, providing each with a maximum data rate of $40 \mathrm{Mbit} / \mathrm{s}$. Independent transmit and receive functions provide greater flexibility for serial communications. Serial port data can be automatically transferred to and from on-chip memory via DMA. Each of the serial ports offers TDM multichannel mode.

The serial ports can operate with little-endian or big-endian transmission formats, with word lengths selectable from 3 bits to 32 bits. They offer selectable synchronization and transmit modes as well as optional $\mu$-law or A-law companding. Serial port clocks and frame syncs can be internally or externally generated.

## Multiprocessing

The ADSP-21062 offers powerful features tailored to multiprocessor DSP systems. The unified address space (see Figure 4) allows direct interprocessor accesses of each ADSP21062's internal memory. Distributed bus arbitration logic is included on-chip for simple, glueless connection of systems containing up to six ADSP-21062s and a host processor. Master processor changeover incurs only one cycle of overhead. Bus arbitration is selectable as either fixed or rotating priority. Bus lock allows indivisible read-modify-write sequences for semaphores. A vector interrupt is provided for interprocessor commands. Maximum throughput for interprocessor data transfer is $240 \mathrm{Mbytes} / \mathrm{s}$ over the link ports or external port. Broadcast writes allow simultaneous transmission of data to all ADSP-21062s and can be used to implement reflective semaphores.

## Link Ports

The ADSP-21062 features six 4-bit link ports that provide additional I/O capabilities. The link ports can be clocked twice per cycle, allowing each to transfer eight bits of data per cycle. Link port I/O is especially useful for point-to-point interprocessor communication in multiprocessing systems.
The link ports can operate independently and simultaneously, with a maximum data throughput of $240 \mathrm{Mbytes} / \mathrm{s}$. Link port data is packed into 32 - or 48-bit words, and can be directly read by the core processor or DMA-transferred to on-chip memory.
Each link port has its own double-buffered input and output registers. Clock/acknowledge handshaking controls link port transfers. Transfers are programmable as either transmit or receive.

## Program Booting

The internal memory of the ADSP-21062 can be booted at system power-up from either an 8 -bit EPROM, a host processor, or through one of the link ports. Selection of the boot source is controlled by the $\overline{\mathrm{B} M \mathrm{~S}}$ (Boot Memory Select), EBOOT (EPROM Boot), and LBOOT (Link/Host Boot) pins. 32 -bit and 16 -bit host processors can be used for booting.


Figure 3. Shared Memory Multiprocessing System


NORMAL WORD ADDRESSING: 32-BIT DATA WORDS 48-BIT INSTRUCTION WORDS SHORT WORD ADDRESSING: 16-BIT DATA WORDS


Figure 4. ADSP-21062/ADSP-21062L Memory Map

## DEVELOPMENT TOOLS

The ADSP-21062 is supported with a complete set of software and hardware development tools, including an EZ-ICE InCircuit Emulator, EZ-LAB ${ }^{\circledR}$ development board, EZ-KIT, and development software. The EZ-LAB contains an evaluation board with an ADSP-21062 ( 5 V ) processor and provides a serial connection to your PC. The SHARC EZ-KIT combines the ADSP21000 Family Development Software for the PC and the EZ-LAB ADSP-21062's Development Board in one package. The EZ-KIT contains in addition to the EZ-LAB development board, an optimizing compiler, assembler, instruction level simulator, run-time libraries, diagnostic utilities and a complete set of example programs.
The same EZ-ICE hardware can be used for the ADSP-21060/ ADSP-21061, to fully emulate the ADSP-21062, with the exception of displaying and modifying the two new SPORTS registers. The emulator will not display these two registers, but your code can use them.
Analog Devices' ADSP-21000 Family Development Software includes an easy to use Assembler based on an algebraic syntax, an Assembly Library/Librarian, a Linker, an Instruction-level Simulator, an ANSI C optimizing Compiler, the CBug ${ }^{\text {TM }} \mathrm{C}$ Source-Level Debugger, and a C Runtime Library including DSP and mathematical functions. The Optimizing Compiler includes Numerical C extensions based on the work of the ANSI Numerical C Extensions Group. Numerical C provides extensions to the C language for array selection, vector math operations, complex data types, circular pointers, and variably

[^1]dimensioned arrays. The ADSP-21000 Family Development Software is available for both the PC and Sun platforms.

The ADSP-21062 EZ-ICE Emulator uses the IEEE 1149.1 JTAG test access port of the ADSP-21062 processor to monitor and control the target board processor during emulation. The EZ-ICE provides full-speed emulation, allowing inspection and modification of memory, registers, and processor stacks. Nonintrusive in-circuit emulation is assured by the use of the processor's JTAG interface-the emulator does not affect target system loading or timing.
Further details and ordering information are available in the ADSP-21000 Family Hardware E Software Development Tools data sheet (ADDS-210xx-TOOLS). This data sheet can be requested from any Analog Devices sales office, distributor or the Literature Center.
In addition to the software and hardware development tools available from Analog Devices, third parties provide a wide range of tools supporting the SHARC processor family. Hardware tools include SHARC PC plug-in cards, multiprocessor SHARC VME boards, and daughter card modules with multiple SHARCs and additional memory. These modules are based on the SHARCPAC ${ }^{\text {TM }}$ module specification. Third party software tools include an Ada compiler, DSP libraries, operating systems, and block diagram design tools.

## ADDITIONAL INFORMATION

This data sheet provides a general overview of the ADSP-21062 architecture and functionality. For detailed information on the ADSP-21000 Family core architecture and instruction set, refer to the ADSP-21062 SHARC User's Manual, Second Edition.

## ADSP-21062/ADSP-21062L

## PIN FUNCTION DESCRIPTIONS

ADSP-21062 pin definitions are listed below. All pins are identical on the ADSP-21062 and ADSP-21062L. Inputs identified as synchronous (S) must meet timing requirements with respect to CLKIN (or with respect to TCK for TMS, TDI). Inputs identified as asynchronous (A) can be asserted asynchronously to CLKIN (or to TCK for TRST).
Unused inputs should be tied or pulled to VDD or GND, except for $\mathrm{ADDR}_{31-0}, \mathrm{DATA}_{47-0}, \mathrm{FLAG}_{3-0}, \overline{\mathrm{SW}}$, and inputs that have internal pull-up or pull-down resistors $(\overline{\mathrm{CPA}}, \mathrm{ACK}, \mathrm{DTx}$,

DRx, TCLKx, RCLKx, LxDAT3-0, LxCLK, LxACK, TMS and TDI)-these pins can be left floating. These pins have a logic-level hold circuit that prevents the input from floating internally.

| $A=$ Asynchronous | $G=$ Ground | $I=$ Input |
| :--- | :--- | :--- |
| $O=$ Output | $P=$ Power Supply | $S=$ Synchronous |
| $(A / D)=$ Active Drive | $(O / D)=$ Open Drain |  |

$\mathrm{A}=$ Asynchronous $\quad \mathrm{G}=$ Ground $\quad \mathrm{I}=$ Input $(A / D)=$ Active Drive $\quad(O / D)=$ Open Drain
$\mathrm{T}=$ Three-State (when SBTS is asserted, or when the ADSP-21062 is a bus slave)

| Pin | Type | Function |
| :---: | :---: | :---: |
| $\mathrm{ADDR}_{31-0}$ | I/O/T | External Bus Address. The ADSP-21062 outputs addresses for external memory and peripherals on these pins. In a multiprocessor system the bus master outputs addresses for read/writes of the internal memory or IOP registers of other ADSP-21062s. The ADSP-21062 inputs addresses when a host processor or multiprocessing bus master is reading or writing its internal memory or IOP registers. |
| $\mathrm{DATA}_{47-0}$ | I/O/T | External Bus Data. The ADSP-21062 inputs and outputs data and instructions on these pins. 32-bit single-precision floating-point data and 32-bit fixed-point data is transferred over bits 47-16 of the bus. 40-bit extended-precision floating-point data is transferred over bits $47-8$ of the bus. 16-bit short word data is transferred over bits $31-16$ of the bus. In PROM boot mode, 8 -bit data is transferred over bits 23-16. Pull-up resistors on unused DATA pins are not necessary. |
| $\overline{\mathrm{MS}}_{3-0}$ | O/T | Memory Select Lines. These lines are asserted (low) as chip selects for the corresponding banks of external memory. Memory bank size must be defined in the ADSP-21062's system control register (SYSCON). The $\overline{\mathrm{MS}}_{3-0}$ lines are decoded memory address lines that change at the same time as the other address lines. When no external memory access is occurring the $\overline{\mathrm{MS}}_{3-0}$ lines are inactive; they are active however when a conditional memory access instruction is executed, whether or not the condition is true. $\overline{\mathrm{MS}}_{0}$ can be used with the PAGE signal to implement a bank of DRAM memory (Bank 0 ). In a multiprocessing system the $\overline{\mathrm{MS}}_{3-0}$ lines are output by the bus master. |
| $\overline{\mathrm{RD}}$ | I/O/T | Memory Read Strobe. This pin is asserted (low) when the ADSP-21062 reads from external memory devices or from the internal memory of other ADSP-21062s. External devices (including other ADSP-21062s) must assert $\overline{\mathrm{RD}}$ to read from the ADSP-21062's internal memory. In a multiprocessing system $\overline{\mathrm{RD}}$ is output by the bus master and is input by all other ADSP-21062s. |
| $\overline{\mathrm{WR}}$ | I/O/T | Memory Write Strobe. This pin is asserted (low) when the ADSP-21062 writes to external memory devices or to the internal memory of other ADSP-21062s. External devices must assert $\overline{\mathrm{WR}}$ to write to the ADSP-21062's internal memory. In a multiprocessing system $\overline{\mathrm{WR}}$ is output by the bus master and is input by all other ADSP-21062s. |
| PAGE | O/T | DRAM Page Boundary. The ADSP-21062 asserts this pin to signal that an external DRAM page boundary has been crossed. DRAM page size must be defined in the ADSP-21062's memory control register (WAIT). DRAM can only be implemented in external memory Bank 0; the PAGE signal can only be activated for Bank 0 accesses. In a multiprocessing system PAGE is output by the bus master. |
| ADRCLK | O/T | Clock Output Reference. In a multiprocessing system ADRCLK is output by the bus master. |
| $\overline{\text { SW }}$ | I/O/T | Synchronous Write Select. This signal is used to interface the ADSP-21062 to synchronous memory devices (including other ADSP-21062s). The ADSP-21062 asserts $\overline{\text { SW }}$ (low) to provide an early indication of an impending write cycle, which can be aborted if $\overline{\mathrm{WR}}$ is not later asserted (e.g., in a conditional write instruction). In a multiprocessing system, $\overline{\mathrm{SW}}$ is output by the bus master and is input by all other ADSP-21062s to determine if the multiprocessor memory access is a read or write. $\overline{\mathrm{SW}}$ is asserted at the same time as the address output. A host processor using synchronous writes must assert this pin when writing to the ADSP-21062(s). |
| ACK | I/O/S | Memory Acknowledge. External devices can deassert ACK (low) to add wait states to an external memory access. ACK is used by I/O devices, memory controllers, or other peripherals to hold off completion of an external memory access. The ADSP-21062 deasserts ACK as an output to add wait states to a synchronous access of its internal memory. In a multiprocessing system, a slave ADSP21062 deasserts the bus master's ACK input to add wait state(s) to an access of its internal memory. The bus master has a keeper latch on its ACK pin that maintains the input at the level to which it was last driven. |


| Pin | Type | Function |
| :---: | :---: | :---: |
| $\overline{\text { SBTS }}$ | I/S | Suspend Bus Three-State. External devices can assert $\overline{\text { SBTS (low) to place the external bus address, }}$ data, selects and strobes in a high impedance state for the following cycle. If the ADSP-21062 attempts to access external memory while $\overline{\text { SBTS }}$ is asserted, the processor will halt and the memory access will not be completed until $\overline{\text { SBTS }}$ is deasserted. $\overline{\text { SBTS }}$ should only be used to recover from host processor/ADSP-21062 deadlock, or used with a DRAM controller. |
| $\overline{\mathrm{IRQ}}_{2-0}$ | I/A | Interrupt Request Lines. May be either edge-triggered or level-sensitive. |
| $\mathrm{FLAG}_{3-0}$ | I/O/A | Flag Pins. Each is configured via control bits as either an input or output. As an input, they can be tested as a condition. As an output, they can be used to signal external peripherals. |
| TIMEXP | O | Timer Expired. Asserted for four cycles when the timer is enabled and TCOUNT decrements to zero. |
| $\overline{\text { HBR }}$ | I/A | Host Bus Request. This pin must be asserted by a host processor to request control of the ADSP-21062's external bus. When $\overline{\mathrm{HBR}}$ is asserted in a multiprocessing system, the ADSP-21062 that is bus master will relinquish the bus and assert $\overline{\mathrm{HBG}}$. To relinquish the bus, the ADSP-21062 places the address, data, select and strobe lines in a high impedance state. $\overline{\mathrm{HBR}}$ has priority over all ADSP-21062 bus requests $\left(\overline{\mathrm{BR}}_{6-1}\right)$ in a multiprocessing system. |
| $\overline{\mathrm{HBG}}$ | I/O | Host Bus Grant. Acknowledges an $\overline{\mathrm{HBR}}$ bus request, indicating that the host processor may take control of the external bus. $\overline{\mathrm{HBG}}$ is asserted (held low) by the ADSP-21062 until $\overline{\mathrm{HBR}}$ is released. In a multiprocessing system, $\overline{\mathrm{HBG}}$ is output by the ADSP-21062 bus master and is monitored by all others. |
| $\overline{\mathrm{CS}}$ | I/A | Chip Select. Asserted by host processor to select the ADSP-21062. |
| REDY (O/D) | O | Host Bus Acknowledge. The ADSP-21062 deasserts REDY (low) to add wait states to an asynchronous access of its internal memory or IOP registers by a host. This pin is an open drain output (O/D) by default; it can be programmed in the ADREDY bit of the SYSCON register to be active drive (A/D). REDY will only be output if the $\overline{\mathrm{CS}}$ and $\overline{\mathrm{HBR}}$ inputs are asserted. |
| $\overline{\text { DMAR1 }}$ | I/A | DMA Request 1 (DMA Channel 7). |
| $\overline{\text { DMAR2 }}$ | I/A | DMA Request 2 (DMA Channel 8). |
| $\overline{\text { DMAG1 }}$ | O/T | DMA Grant 1 (DMA Channel 7). |
| $\overline{\text { DMAG2 }}$ | O/T | DMA Grant 2 (DMA Channel 8). |
| $\overline{\mathrm{BR}}_{6-1}$ | I/O/S | Multiprocessing Bus Requests. Used by multiprocessing ADSP-21062s to arbitrate for bus mastership. An ADSP- 21062 only drives its own $\overline{\mathrm{BR}} \mathrm{x}$ line (corresponding to the value of its $\mathrm{ID}_{2-0}$ inputs) and monitors all others. In a multiprocessor system with less than six ADSP-21062s, the unused $\overline{\mathrm{BR}} \mathrm{x}$ pins should be pulled high; the processor's own $\overline{\mathrm{BRx}}$ line must not be pulled high or low because it is an output. |
| $\mathrm{ID}_{2-0}$ | I | Multiprocessing ID. Determines which multiprocessing bus request $(\overline{\mathrm{BR} 1}-\overline{\mathrm{BR} 6})$ is used by ADSP21062. ID $=001$ corresponds to $\overline{\mathrm{BR} 1}, \mathrm{ID}=010$ corresponds to $\overline{\mathrm{BR} 2}$, etc. $\mathrm{ID}=000$ in single-processor systems. These lines are a system configuration selection which should be hardwired or changed at reset only. |
| RPBA | I/S | Rotating Priority Bus Arbitration Select. When RPBA is high, rotating priority for multiprocessor bus arbitration is selected. When RPBA is low, fixed priority is selected. This signal is a system configuration selection which must be set to the same value on every ADSP-21062. If the value of RPBA is changed during system operation, it must be changed in the same CLKIN cycle on every ADSP-21062. |
| $\overline{\mathrm{CPA}}$ (O/D) | I/O | Core Priority Access. Asserting its $\overline{\mathrm{CPA}}$ pin allows the core processor of an ADSP-21062 bus slave to interrupt background DMA transfers and gain access to the external bus. $\overline{\mathrm{CPA}}$ is an open drain output that is connected to all ADSP-21062s in the system. The $\overline{\mathrm{CPA}}$ pin has an internal $5 \mathrm{k} \Omega$ pull-up resistor. If core access priority is not required in a system, the $\overline{\mathrm{CPA}}$ pin should be left unconnected. |
| DTx | O | Data Transmit (Serial Ports 0, 1). Each DT pin has a $50 \mathrm{k} \Omega$ internal pull-up resistor. |
| DRx | I | Data Receive (Serial Ports 0, 1). Each DR pin has a $50 \mathrm{k} \Omega$ internal pull-up resistor. |
| TCLKx | I/O | Transmit Clock (Serial Ports 0, 1). Each TCLK pin has a $50 \mathrm{k} \Omega$ internal pull-up resistor. |
| RCLKx | I/O | Receive Clock (Serial Ports 0, 1). Each RCLK pin has a $50 \mathrm{k} \Omega$ internal pull-up resistor. |


| Pin | Type | Function |
| :---: | :---: | :---: |
| TFSx | I/O | Transmit Frame Sync (Serial Ports 0, 1). |
| RFSx | I/O | Receive Frame Sync (Serial Ports 0, 1). |
| $\mathrm{LxDAT}_{3-0}$ | I/O | Link Port Data (Link Ports 0-5). Each LxDAT pin has a $50 \mathrm{k} \Omega$ internal pull-down resistor that is enabled or disabled by the LPDRD bit of the LCOM register. |
| LxCLK | I/O | Link Port Clock (Link Ports 0-5). Each LxCLK pin has a $50 \mathrm{k} \Omega$ internal pull-down resistor that is enabled or disabled by the LPDRD bit of the LCOM register. |
| LxACK | I/O | Link Port Acknowledge (Link Ports 0-5). Each LxACK pin has a $50 \mathrm{k} \Omega$ internal pull-down resistor that is enabled or disabled by the LPDRD bit of the LCOM register. |
| EBOOT | I | EPROM Boot Select. When EBOOT is high, the ADSP-21062 is configured for booting from an 8bit EPROM. When EBOOT is low, the LBOOT and $\overline{\text { BMS }}$ inputs determine booting mode. See table below. This signal is a system configuration selection that should be hardwired. |
| LBOOT | I | Link Boot. When LBOOT is high, the ADSP-21062 is configured for link port booting. When LBOOT is low, the ADSP-21062 is configured for host processor booting or no booting. See table below. This signal is a system configuration selection that should be hardwired. |
| $\overline{\text { BMS }}$ | I/O/T* | Boot Memory Select. Output: Used as chip select for boot EPROM devices (when EBOOT = 1, LBOOT $=0$ ). In a multiprocessor system, $\overline{\mathrm{BMS}}$ is output by the bus master. Input: When low, indicates that no booting will occur and that ADSP-21062 will begin executing instructions from external memory. See table below. This input is a system configuration selection that should be hardwired. <br> *Three-statable only in EPROM boot mode (when $\overline{\text { BMS }}$ is an output). |
| CLKIN | I | Clock In. External clock input to the ADSP-21062. The instruction cycle rate is equal to CLKIN. CLKIN may not be halted, changed, or operated below the minimum specified frequency. |
| $\overline{\text { RESET }}$ | I/A | Processor Reset. Resets the ADSP-21062 to a known state and begins program execution at the program memory location specified by the hardware reset vector address. This input must be asserted (low) at power-up. |
| TCK | I | Test Clock (JTAG). Provides an asynchronous clock for JTAG boundary scan. |
| TMS | I/S | Test Mode Select (JTAG). Used to control the test state machine. TMS has a $20 \mathrm{k} \Omega$ internal pull-up resistor. |
| TDI | I/S | Test Data Input (JTAG). Provides serial data for the boundary scan logic. TDI has a $20 \mathrm{k} \Omega$ internal pull-up resistor. |
| TDO | O | Test Data Output (JTAG). Serial scan output of the boundary scan path. |
| $\overline{\text { TRST }}$ | I/A | Test Reset (JTAG). Resets the test state machine. $\overline{\text { TRST }}$ must be asserted (pulsed low) after powerup or held low for proper operation of the ADSP-21062. TRST has a $20 \mathrm{k} \Omega$ internal pull-up resistor. |
| $\overline{\text { EMU }}$ | O | Emulation Status. Must be connected to the ADSP-21062 EZ-ICE target board connector only. |
| ICSA | O | Reserved, leave unconnected. |
| VDD | P | Power Supply; nominally +5.0 V dc for 5 V devices or +3.3 V dc for 3.3 V devices. ( 30 pins) |
| GND | G | Power Supply Return. (30 pins) |
| NC |  | Do Not Connect. Reserved pins which must be left open and unconnected. |

## ADSP-21062/ADSP-21062L

## TARGET BOARD CONNECTOR FOR EZ-ICE PROBE

The ADSP-2106x EZ-ICE Emulator uses the IEEE 1149.1 JTAG test access port of the ADSP-2106x to monitor and control the target board processor during emulation. The EZICE probe requires the ADSP-2106x's CLKIN, TMS, TCK, TRST, TDI, TDO, $\overline{\text { EMU, and GND signals be made acces- }}$ sible on the target system via a 14-pin connector (a 2 row $\times 7$ pin strip header) such as that shown in Figure 5. The EZ-ICE probe plugs directly onto this connector for chip-on-board emulation. You must add this connector to your target board design if you intend to use the ADSP-2106x EZ-ICE. The total trace length between the EZ-ICE connector and the furthest device sharing the EZ-ICE JTAG pin should be limited to 15 inches maximum for guaranteed operation. This length restriction must include EZ-ICE JTAG signals that are routed to one or more ADSP-2106x devices, or a combination of ADSP2106x devices and other JTAG devices on the chain.


The 14-pin, 2-row pin strip header is keyed at the Pin 3 location Pin 3 must be removed from the header. The pins must be 0.025 inch square and at least 0.20 inch in length. Pin spacing should be $0.1 \times 0.1$ inches. Pin strip headers are available from vendors such as 3 M , McKenzie, and Samtec.
The BTMS, BTCK, $\overline{\text { BTRST, }}$, and BTDI signals are provided so that the test access port can also be used for board-level testing. When the connector is not being used for emulation, place jumpers between the BXXX pins and the XXX pins as shown in Figure 5. If you are not going to use the test access port for board testing, tie BTRST to GND and tie or pull up BTCK to VDD. The TRST pin must be asserted after power-up (through $\overline{\text { BTRST }}$ on the connector) or held low for proper operation of the ADSP-2106x. None of the BXXX pins (Pins 5, 7, 9, 11) are connected on the EZ-ICE probe.
The JTAG signals are terminated on the EZ-ICE probe as follows:

| Signal | Termination |
| :--- | :--- |
| TMS | Driven through $22 \Omega$ Resistor $(16 \mathrm{~mA}$ Driver) <br> Driven at 10 MHz through $22 \Omega$ Resistor (16 mA <br> Triver) |
| TRST $^{\star}$ | Active Low Driven through $22 \Omega$ Resistor (16 mA <br> Driver) (Pulled Up by On-Chip $20 \mathrm{k} \Omega$ Resistor) |
| TDI | Driven by 22 $\Omega$ Resistor (16 mA Driver) <br> One TTL Load, Split Termination (160/220) |
| TDO | OLKIN <br> One TTL Load, Split Termination (160/220) <br> Active Low 4.7 k Pull-Up Resistor, One TTL Load <br> (Open-Drain Output from the DSP) |
| EMU |  |

$\star \overline{\text { TRST }}$ is driven low until the EZ-ICE probe is turned on by the emulator at software start-up. After software start-up, $\overline{\mathrm{TRST}}$ is driven high.

Figure 5. Target Board Connector For ADSP-2106x EZ-ICE Emulator (Jumpers in Place)


Figure 6. JTAG Scan Path Connections for Multiple ADSP-2106x Systems

## ADSP-21062/ADSP-21062L

Figure 6 shows JTAG scan path connections for systems that contain multiple ADSP-2106x processors.
Connecting CLKIN to Pin 4 of the EZ-ICE header is optional. The emulator only uses CLKIN when directed to perform operations such as starting, stopping, and single-stepping multiple ADSP-2106xs in a synchronous manner. If you do not need these operations to occur synchronously on the multiple processors, simply tie Pin 4 of the EZ-ICE header to ground.
If synchronous multiprocessor operations are needed and CLKIN is connected, clock skew between the multiple ADSP21062 processors and the CLKIN pin on the EZ-ICE header must be minimal. If the skew is too large, synchronous operations may be off by one or more cycles between processors. For synchronous multiprocessor operation TCK, TMS, CLKIN and
$\overline{\text { EMU }}$ should be treated as critical signals in terms of skew, and should be laid out as short as possible on your board. If TCK, TMS, and CLKIN are driving a large number of ADSP21062s (more than eight) in your system, then treat them as a "clock tree" using multiple drivers to minimize skew. (See Figure 7 "JTAG Clock Tree" and "Clock Distribution" in the "High Frequency Design Considerations" section of the ADSP$2106 x$ User's Manual, Second Edition.)
If synchronous multiprocessor operations are not needed (i.e., CLKIN is not connected), just use appropriate parallel termination on TCK and TMS. TDI, TDO, $\overline{\text { EMU }}$ and TRST are not critical signals in terms of skew.
For complete information on the SHARC EZ-ICE, see the ADSP-21000 Family fTAG EZ-ICE User's Guide and Reference.


Figure 7. JTAG Clocktree for Multiple ADSP-2106x Systems

## ADSP-21062-SPECIFICATIONS

RECOMMENDED OPERATING CONDITIONS ( 5 V )

| Parameter |  | Test Conditions | A Grade |  | C Grade |  | K Grade |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Max | Min | Max | Min | Max |  |
| $\mathrm{V}_{\mathrm{DD}}$ | Supply Voltage |  |  | 4.75 | 5.25 | 4.75 | 5.25 | 4.75 | 5.25 | V |
| $\mathrm{T}_{\text {CASE }}$ | Case Operating Temperature |  | -40 | +85 | -40 | +100 | 0 | +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{V}_{\mathrm{IH} 1}$ | High Level Input Voltage ${ }^{1}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\max$ | 2.0 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | 2.0 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | 2.0 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | V |
| $\mathrm{V}_{\mathrm{IH} 2}$ | High Level Input Voltage ${ }^{2}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\max$ | 2.2 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | 2.2 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | 2.2 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | V |
| $\mathrm{V}_{\text {IL }}$ | Low Level Input Voltage ${ }^{1,2}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\min$ | -0.5 | 0.8 | -0.5 | 0.8 | -0.5 | 0.8 | V |

NOTES
${ }^{1}$ Applies to input and bidirectional pins: $\mathrm{DATA}_{47-0}, \mathrm{ADDR}_{31-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \overline{\mathrm{SW}}, \mathrm{ACK}, \overline{\mathrm{SBTS}}, \overline{\mathrm{IRQ}}_{2-0}, \mathrm{FLAG}_{3-0}, \overline{\mathrm{HBG}}, \overline{\mathrm{CS}}, \overline{\mathrm{DMAR}}, \overline{\mathrm{DMAR}}, \overline{\mathrm{BR}_{6-1}}, \mathrm{ID}_{2-0}, \mathrm{RPBA}$

${ }^{2}$ Applies to input pins: CLKIN, $\overline{\text { RESET, }}$ TRST.

## ELECTRICAL CHARACTERISTICS (5 V)

| Parameter |  | Test Conditions | Min | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | High Level Output Voltage ${ }^{1}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\min , \mathrm{I}_{\mathrm{OH}}=-2.0 \mathrm{~mA}^{2}$ | 4.1 |  | V |
| $\mathrm{V}_{\text {OL }}$ | Low Level Output Voltage ${ }^{1}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\min , \mathrm{I}_{\mathrm{OL}}=4.0 \mathrm{~mA}^{2}$ |  | 0.4 | V |
| $\mathrm{I}_{\mathrm{IH}}$ | High Level Input Current ${ }^{3,4}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\max , \mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{DD}} \max$ |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {IL }}$ | Low Level Input Current ${ }^{3}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {ILP }}$ | Low Level Input Current ${ }^{4}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ |  | 150 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZH }}$ | Three-State Leakage Current ${ }^{5}$, 6, 7, 8 | (a) $\mathrm{V}_{\mathrm{DD}}=\max , \mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{DD}}$ max |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZL }}$ | Three-State Leakage Current ${ }^{5,9}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\text {IN }}=0 \mathrm{~V}$ |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZHP }}$ | Three-State Leakage Current ${ }^{9}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\max , \mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{DD}}$ max |  | 350 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZLC }}$ | Three-State Leakage Current ${ }^{7}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\text {IN }}=0 \mathrm{~V}$ |  | 1.5 | mA |
| I OZLA | Three-State Leakage Current ${ }^{10}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\max , \mathrm{V}_{\mathrm{IN}}=1.5 \mathrm{~V}$ |  | 350 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZLAR }}$ | Three-State Leakage Current ${ }^{8}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ |  | 4.2 | mA |
| $\mathrm{I}_{\text {OZLS }}$ | Three-State Leakage Current ${ }^{6}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\text {IN }}=0 \mathrm{~V}$ |  | 150 | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {IN }}$ | Input Capacitance ${ }^{11,12}$ | $\mathrm{f}_{\mathrm{IN}}=1 \mathrm{MHz}, \mathrm{T}_{\mathrm{CASE}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{IN}}=2.5 \mathrm{~V}$ |  | 4.7 | pF |

## NOTES

${ }^{1}$ Applies to output and bidirectional pins: $\mathrm{DATA}_{47-0}, \mathrm{ADDR}_{31-0}, \overline{\mathrm{MS}}_{3-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}$, PAGE, ADRCLK, $\overline{\mathrm{SW}}, \mathrm{ACK}, \mathrm{FLAG}_{3-0}$, TIMEXP, $\overline{\mathrm{HBG}}, \mathrm{REDY}, \overline{\mathrm{DMAG1}}$, $\overline{\mathrm{DMAG} 2}, \overline{\mathrm{BR}}_{6-1}, \overline{\mathrm{CPA}}, \mathrm{DT} 0, \mathrm{DT1}, \mathrm{TCLK} 0, ~ T C L K 1, ~ R C L K 0, ~ R C L K 1, ~ T F S 0, ~ T F S 1, ~ R F S 0, ~ R F S 1, ~ L x D A T ~ 3-0, ~ L x C L K, ~ L x A C K, ~ \overline{B M S}, ~ T D O, ~ \overline{E M U, ~ I C S A . ~}$
${ }^{2}$ See "Output Drive Currents" for typical drive current capabilities.
${ }^{3}$ Applies to input pins: ACK $\overline{\mathrm{SBTS}}, \overline{\mathrm{IRQ}}_{2-0}, \overline{\mathrm{HBR}}, \overline{\mathrm{CS}}, \overline{\mathrm{DMAR} 1}, \overline{\mathrm{DMAR} 2}, \mathrm{ID}_{2-0}$, RPBA, EBOOT, LBOOT, CLKIN, $\overline{\mathrm{RESET}}, \mathrm{TCK}$.
${ }^{4}$ Applies to input pins with internal pull-ups: DR0, DR1, TRST, TMS, TDI.
${ }^{5}$ Applies to three-statable pins: $\mathrm{DATA}_{47-0}, \mathrm{ADDR}_{31-0}, \overline{\mathrm{MS}}_{3-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \mathrm{PAGE}, \mathrm{ADRCLK}, \overline{\mathrm{SW}}, \mathrm{ACK}, \mathrm{FLAG}_{3-0}, \mathrm{REDY}, \overline{\mathrm{HBG}}, \overline{\mathrm{DMAG}}, \overline{\mathrm{DMAG}}, \overline{\mathrm{BMS}}, \overline{\mathrm{BR}}(6-1$, $\mathrm{TFS}_{\mathrm{X}}, \mathrm{RFS}_{\mathrm{x}}, \mathrm{TDO}, \overline{\mathrm{EMU}}$. (Note that ACK is pulled up internally with $2 \mathrm{k} \Omega$ during reset in a multiprocessor system, when $\mathrm{ID}_{2-0}=001$ and another ADSP-21062 is not requesting bus mastership.)
${ }^{6}$ Applies to three-statable pins with internal pull-ups: DT0, DT1, TCLK0, TCLK1, RCLK0, RCLK1.
${ }^{7}$ Applies to $\overline{\mathrm{CPA}}$ pin.
${ }^{8}$ Applies to ACK pin when pulled up. (Note that ACK is pulled up internally with $2 \mathrm{k} \Omega$ during reset in a multiprocessor system, when $\mathrm{ID}_{2-0}=001$ and another ADSP-21062L is not requesting bus mastership).
${ }^{9}$ Applies to three-statable pins with internal pull-downs: $\operatorname{LxDAT}_{3-0}, \operatorname{LxCLK}, \operatorname{LxACK}$.
${ }^{10}$ Applies to ACK pin when keeper latch enabled.
${ }^{11}$ Applies to all signal pins.
${ }^{12}$ Guaranteed but not tested.
Specifications subject to change without notice.

## ADSP-21062/ADSP-21062L

## POWER DISSIPATION ADSP-21062 (5 V)

These specifications apply to the internal power portion of $V_{D D}$ only. See the Power Dissipation section of this data sheet for calculation of external supply current and total supply current. For a complete discussion of the code used to measure power dissipation, see the technical note "SHARC Power Dissipation Measurements."

Specifications are based on the following operating scenarios:

| Operation | Peak Activity (I $\left.\mathbf{I}_{\text {DDINPEAK }}\right)$ | High Activity ( $\left.\mathbf{I}_{\text {DDINHIGH }}\right)$ | Low Activity (I $\left.\mathbf{I}_{\text {DDINLOw }}\right)$ |
| :--- | :--- | :--- | :--- |
| Instruction Type | Multifunction | Multifunction | Single Function |
| Instruction Fetch | Cache | Internal Memory | Internal Memory |
| Core Memory Access | 2 per Cycle (DM and PM) | 1 per Cycle (DM) | None |
| Internal Memory DMA | 1 per Cycle | 1 per 2 Cycles | 1 per 2 Cycles |

To estimate power consumption for a specific application, use the following equation where $\%$ is the amount of time your program spends in that state:

$$
\% P E A K \times I_{D D I N P E A K}+\% H I G H \times I_{D D I N H I G H}+\% L O W \times I_{D D I N L O W}+\% I D L E \times I_{D D I D L E}=\text { power consumption }
$$

| Parameter | Test Conditions | Max | Units |  |
| :--- | :--- | :--- | :--- | :--- |
| $\mathrm{I}_{\text {DDINPEAK }}$ | Supply Current (Internal) ${ }^{1}$ | $\mathrm{t}_{\mathrm{CK}}=30 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 745 | mA |
| $\mathrm{I}_{\text {DDINHIGH }}$ |  | Supply Current (Internal) ${ }^{2}$ | $\mathrm{t}_{\mathrm{CK}}=25 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | mA |
|  | $\mathrm{t}_{\mathrm{CK}}=30 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 575 | mA |  |
| $\mathrm{I}_{\text {DDINLOW }}$ | Supply Current (Internal) $)^{2}$ | $\mathrm{t}_{\mathrm{CK}}=25 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 670 | mA |
|  | $\mathrm{t}_{\mathrm{CK}}=30 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | mA |  |  |
| $\mathrm{I}_{\text {DDIDLE }}$ |  | $\mathrm{t}_{\mathrm{CK}}=25 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 340 | mA |

## NOTES

${ }^{1}$ The test program used to measure $I_{\text {DDINPEAK }}$ represents worst case processor operation and is not sustainable under normal application conditions. Actual internal power measurements made using typical applications are less than specified.
${ }^{2} \mathrm{I}_{\text {DDINHIGH }}$ is a composite average based on a range of high activity code. $\mathrm{I}_{\text {DDINLOw }}$ is a composite average based on a range of low activity code.
${ }^{3}$ Idle denotes ADSP-21062L state during execution of IDLE instruction.

| Parameter |  | Test Conditions | A Grade |  | C Grade |  | K Grade |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Max | Min | Max | Min | Max |  |
| $\mathrm{V}_{\mathrm{DD}}$ | Supply Voltage |  |  | 3.15 | 3.45 | 3.15 | 3.45 | 3.15 | 3.45 | V |
| $\mathrm{T}_{\text {CASE }}$ | Case Operating Temperature |  | -40 | +85 | -40 | +100 | 0 | +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{V}_{\mathrm{IH} 1}$ | High Level Input Voltage ${ }^{1}$ | (a) $\mathrm{V}_{\mathrm{DD}}=$ max | 2.0 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | 2.0 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | 2.0 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | V |
| $\mathrm{V}_{\mathrm{IH} 2}$ | High Level Input Voltage ${ }^{2}$ | (a) $\mathrm{V}_{\mathrm{DD}}=$ max | 2.2 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | 2.2 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | 2.2 | $\mathrm{V}_{\mathrm{DD}}+0.5$ | V |
| $\mathrm{V}_{\text {IL }}$ | Low Level Input Voltage ${ }^{1,2}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{min}$ | -0.5 | 0.8 | -0.5 | 0.8 | -0.5 | 0.8 | V |

NOTES
${ }^{1}$ Applies to input and bidirectional pins: $\mathrm{DATA}_{47-0}, \mathrm{ADDR}_{31-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \overline{\mathrm{SW}}, \mathrm{ACK}, \overline{\mathrm{SBTS}}, \overline{\mathrm{IR}}_{2-0}, \mathrm{FLAG}_{3-0}, \overline{\mathrm{HBG}}, \overline{\mathrm{CS}}, \overline{\mathrm{DMAR1}}, \overline{\mathrm{DMAR} 2}, \overline{\mathrm{BR}}_{6-1}, \mathrm{ID}_{2-0}, \mathrm{RPBA}$, $\overline{C P A}$, TFSO, TFS1, RFS0, RFS1, LxDAT ${ }_{3-0}$, LxCLK, LxACK, EBOOT, LBOOT, $\overline{B M S}$, TMS, TDI, TCK, $\overline{\mathrm{HBR}}, \mathrm{DR} 0, \mathrm{DR1}, \mathrm{TCLK0}, \mathrm{TCLK} 1$, RCLK0, RCLK1. ${ }^{2}$ Applies to input pins: CLKIN, $\overline{\text { RESET, }}$ TRST.

## ELECTRICAL CHARACTERISTICS (3.3 V)

| Parameter |  | Test Conditions | Min | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | High Level Output Voltage ${ }^{1}$ | ( $\mathrm{V}_{\mathrm{DD}}=\min , \mathrm{I}_{\mathrm{OH}}=-2.0 \mathrm{~mA}^{2}$ | 2.4 |  | V |
| $\mathrm{V}_{\text {OL }}$ | Low Level Output Voltage ${ }^{1}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\min , \mathrm{I}_{\mathrm{OL}}=4.0 \mathrm{~mA}^{2}$ |  | 0.4 | V |
| $\mathrm{I}_{\mathrm{IH}}$ | High Level Input Current ${ }^{3,4}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\max , \mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{DD}}$ max |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {IL }}$ | Low Level Input Current ${ }^{3}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {ILP }}$ | Low Level Input Current ${ }^{4}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ |  | 150 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZH }}$ | Three-State Leakage Current ${ }^{5}$, 6, 7, 8 | (a) $\mathrm{V}_{\mathrm{DD}}=\max , \mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{DD}} \max$ |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OzL }}$ | Three-State Leakage Current ${ }^{\text {5,9 }}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\max , \mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZHP }}$ | Three-State Leakage Current ${ }^{9}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\max , \mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{DD}}$ max |  | 350 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZLC }}$ | Three-State Leakage Current ${ }^{7}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\text {IN }}=0 \mathrm{~V}$ |  | 1.5 | mA |
| I OZLA | Three-State Leakage Current ${ }^{10}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\mathrm{IN}}=1.5 \mathrm{~V}$ |  | 350 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OZLAR }}$ | Three-State Leakage Current ${ }^{8}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ |  | 4.2 | mA |
| $\mathrm{I}_{\text {OZLS }}$ | Three-State Leakage Current ${ }^{6}$ | (a) $\mathrm{V}_{\mathrm{DD}}=\mathrm{max}, \mathrm{V}_{\text {IN }}=0 \mathrm{~V}$ |  | 150 | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {IN }}$ | Input Capacitance ${ }^{11,12}$ | $\mathrm{f}_{\mathrm{IN}}=1 \mathrm{MHz}, \mathrm{T}_{\mathrm{CASE}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{IN}}=2.5 \mathrm{~V}$ |  | 4.7 | pF |

## NOTES

${ }^{1}$ Applies to output and bidirectional pins: $\mathrm{DATA}_{47-0}, \mathrm{ADDR}_{31-0}, \overline{\mathrm{MS}}_{3-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \mathrm{PAGE}, \mathrm{ADRCLK}, \overline{\mathrm{SW}}, \mathrm{ACK}, \mathrm{FLAG}_{3-0}$, TIMEXP, $\overline{\mathrm{HBG}}, \mathrm{REDY}, \overline{\mathrm{DMAG1}}$,
$\overline{\mathrm{DMAG} 2}, \overline{\mathrm{BR}}_{6-1}, \overline{\mathrm{CPA}}, \mathrm{DT} 0, \mathrm{DT1}, \mathrm{TCLK} 0$, TCLK1, RCLK0, RCLK1, TFS0, TFS1, RFS0, RFS1, LxDAT $3-0$, LxCLK, LxACK, $^{\mathrm{BMS}}, \mathrm{TDO}, \overline{\mathrm{EMU}}, \mathrm{ICSA}$.
${ }^{2}$ See "Output Drive Currents" for typical drive current capabilities.
${ }^{3}$ Applies to input pins: ACK $\overline{\mathrm{SBTS}}, \overline{\mathrm{IRQ}}_{2-0}, \overline{\mathrm{HBR}}, \overline{\mathrm{CS}}, \overline{\mathrm{DMAR1}}, \overline{\mathrm{DMAR} 2}, \mathrm{ID}_{2-0}$, RPBA, EBOOT, LBOOT, CLKIN, $\overline{\mathrm{RESET}}, \mathrm{TCK}$.
${ }^{4}$ Applies to input pins with internal pull-ups: DR0, DR1, TRST, TMS, TDI.
${ }^{5}$ Applies to three-statable pins: $\mathrm{DATA}_{47-0}, \operatorname{ADDR}_{31-0}, \overline{\mathrm{MS}}_{3-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \mathrm{PAGE}, \mathrm{ADRCLK}, \overline{\mathrm{SW}}, \mathrm{ACK}, \mathrm{FLAG}_{3-0}, \mathrm{REDY}, \overline{\mathrm{HBG}}, \overline{\mathrm{DMAG1}}, \overline{\mathrm{DMAG} 2}, \overline{\mathrm{BMS}}, \overline{\mathrm{BR}}{ }_{6-1}$,
$\mathrm{TFS}_{\mathrm{X}}, \mathrm{RFS}_{\mathrm{X}}$, TDO, $\overline{\mathrm{EMU}}$. (Note that ACK is pulled up internally with $2 \mathrm{k} \Omega$ during reset in a multiprocessor system, when $\mathrm{ID}_{2-0}=001$ and another ADSP- 21062 is not requesting bus mastership.)
${ }^{6}$ Applies to three-statable pins with internal pull-ups: DT0, DT1, TCLK0, TCLK1, RCLK0, RCLK1.
${ }^{7}$ Applies to $\overline{\mathrm{CPA}}$ pin.
${ }^{8}$ Applies to ACK pin when pulled up. (Note that ACK is pulled up internally with $2 \mathrm{k} \Omega$ during reset in a multiprocessor system, when $\mathrm{ID}_{2-0}=001$ and another ADSP-21062L is not requesting bus mastership).
${ }^{9}$ Applies to three-statable pins with internal pull-downs: $\operatorname{LxDAT}_{3-0}, \operatorname{LxCLK}, \mathrm{LxACK}$.
${ }^{10}$ Applies to ACK pin when keeper latch enabled.
${ }^{11}$ Applies to all signal pins.
${ }^{12}$ Guaranteed but not tested.
Specifications subject to change without notice.

## ADSP-21062/ADSP-21062L

POWER DISSIPATION ADSP-21062L (3.3 V)
These specifications apply to the internal power portion of $\mathrm{V}_{\mathrm{DD}}$ only. See the Power Dissipation section of this data sheet for calculation of external supply current and total supply current. For a complete discussion of the code used to measure power dissipation, see the technical note "SHARC Power Dissipation Measurements."
Specifications are based on the following operating scenarios:

| Operation | Peak Activity (I $\mathbf{I D D I N P E A K})$ | High Activity (I $\left.\mathbf{I}_{\text {DDINHIGH }}\right)$ | Low Activity (I $\left.\mathbf{I}_{\text {Ddinlow }}\right)$ |
| :--- | :--- | :--- | :--- |
| Instruction Type | Multifunction | Multifunction | Single Function |
| Instruction Fetch | Cache | Internal Memory | Internal Memory |
| Core Memory Access | 2 per Cycle (DM and PM) | 1 per Cycle (DM) | None |
| Internal Memory DMA | 1 per Cycle | 1 per 2 Cycles | 1 per 2 Cycles |

To estimate power consumption for a specific application, use the following equation where $\%$ is the amount of time your program spends in that state:
$\%$ PEAK $\times I_{\text {DDINPEAK }}+\% H I G H \times I_{\text {DDINHIGH }}+\% L O W \times I_{\text {DDINLOW }}+\% I D L E \times I_{\text {DDIDLE }}=$ power consumption

| Parameter |  | Test Conditions | Max | Units |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {DIINPEAK }}$ | Supply Current (Internal) ${ }^{1}$ | $\mathrm{t}_{\mathrm{CK}}=30 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 540 | mA |
|  |  | $\mathrm{t}_{\mathrm{CK}}=25 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 600 | mA |
| $\mathrm{I}_{\text {DDINHIGH }}$ | Supply Current (Internal) ${ }^{2}$ | $\mathrm{t}_{\mathrm{CK}}=30 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 425 | mA |
|  |  | $\mathrm{t}_{\mathrm{CK}}=25 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 475 | mA |
| $\mathrm{I}_{\text {DDINLOW }}$ | Supply Current (Internal) ${ }^{2}$ | $\mathrm{t}_{\mathrm{CK}}=30 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 250 | mA |
|  |  | $\mathrm{t}_{\mathrm{CK}}=25 \mathrm{~ns}, \mathrm{~V}_{\mathrm{DD}}=\max$ | 275 | mA |
| $\mathrm{I}_{\text {DDIDLE }}$ | Supply Current (Idle) ${ }^{3}$ | $\mathrm{V}_{\mathrm{DD}}=\max$ | 180 | mA |

## NOTES

${ }^{1}$ The test program used to measure $I_{\text {DDINPEAK }}$ represents worst case processor operation and is not sustainable under normal application conditions. Actual internal power measurements made using typical applications are less than specified.
${ }^{2} \mathrm{I}_{\text {DDINHIGH }}$ is a composite average based on a range of high activity code. $\mathrm{I}_{\text {DDINLow }}$ is a composite average based on a range of low activity code.
${ }^{3}$ Idle denotes ADSP-21062L state during execution of IDLE instruction.

## ABSOLUTE MAXIMUM RATINGS (5 V DEVICE) ${ }^{\star}$

Supply Voltage . . . . . . . . . . . . . . . . . . . . . . . . . -0.3 V to +7 V
Input Voltage . . . . . . . . . . . . . . . . . . . . -0.5 V to $\mathrm{V}_{\mathrm{DD}}+0.5 \mathrm{~V}$
Output Voltage Swing . . . . . . . . . . . . . -0.5 V to $\mathrm{V}_{\mathrm{DD}}+0.5 \mathrm{~V}$
Load Capacitance . . . . . . . . . . . . . . . . . . . . . . . . . . . 200 pF
Junction Temperature Under Bias . . . . . . . . . . . . . . . . $130^{\circ} \mathrm{C}$
Storage Temperature Range . . . . . . . . . . . . $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$
Lead Temperature ( 5 seconds) . . . . . . . . . . . . . . . . . $+280^{\circ} \mathrm{C}$
*Stresses greater than those listed above may cause permanent damage to the device. These are stress ratings only; functional operation of the device at these or any other conditions greater than those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ABSOLUTE MAXIMUM RATINGS (3.3 V DEVICE) ${ }^{\star}$<br>Supply Voltage . . . . . . . . . . . . . . . . . . . . . . . -0.3 V to +4.6 V<br>Input Voltage . . . . . . . . . . . . . . . . . . . . -0.5 V to $\mathrm{V}_{\mathrm{DD}}+0.5 \mathrm{~V}$<br>Output Voltage Swing . . . . . . . . . . . . . -0.5 V to $\mathrm{V}_{\mathrm{DD}}+0.5 \mathrm{~V}$<br>Load Capacitance . . . . . . . . . . . . . . . . . . . . . . . . . . . 200 pF<br>Junction Temperature Under Bias . . . . . . . . . . . . . . . $130^{\circ} \mathrm{C}$<br>Storage Temperature Range . . . . . . . . . . . . $65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$<br>Lead Temperature ( 5 seconds) . . . . . . . . . . . . . . . . $+280^{\circ} \mathrm{C}$<br>*Stresses greater than those listed above may cause permanent damage to the device. These are stress ratings only; functional operation of the device at these or any other conditions greater than those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ESD SENSITIVITY

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the ADSP-21062 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

## TIMING SPECIFICATIONS

## GENERAL NOTES

Two speed grades of the ADSP-21062 will be offered, 40 MHz and 33.3 MHz . The specifications shown are based on a CLKIN frequency of 40 MHz ( $\mathrm{t}_{\mathrm{CK}}=25 \mathrm{~ns}$ ). The DT derating allows specifications at other CLKIN frequencies (within the min-max range of the $t_{\mathrm{CK}}$ specification; see Clock Input below). DT is the difference between the actual CLKIN period and a CLKIN period of 25 ns :

$$
D T=t_{C K}-25 n s
$$

Use the exact timing information given. Do not attempt to derive parameters from the addition or subtraction of others. While addition or subtraction would yield meaningful results for an individual device, the values given in this data sheet reflect statistical variations and worst cases. Consequently, you cannot meaningfully add parameters to derive longer times.
For voltage reference levels, see Figure 27 under Test Conditions.

Switching Characteristics specify how the processor changes its signals. You have no control over this timing-circuitry external to the processor must be designed for compatibility with these signal characteristics. Switching characteristics tell you what the processor will do in a given circumstance. You can also use switching characteristics to ensure that any timing requirement of a device connected to the processor (such as memory) is satisfied.
Timing Requirements apply to signals that are controlled by circuitry external to the processor, such as the data input for a read operation. Timing requirements guarantee that the processor operates correctly with other devices.
(O/D) = Open Drain
$(\mathrm{A} / \mathrm{D})=$ Active Drive

cLKin


Figure 8. Clock Input

|  | ADSP-21062 <br> Parameter |  | ADSP-21062L |  |
| :--- | :---: | :---: | :---: | :---: |
| Reset | Min | Max | Min | Max |

NOTES
${ }^{1}$ Applies after the power-up sequence is complete. At power-up, the processor's internal phase-locked loop requires no more than 2000 CLKIN cycles while RESET is low, assuming stable $\mathrm{V}_{\mathrm{DD}}$ and CLKIN (not including start-up time of external clock oscillator).
${ }^{2}$ Only required if multiple ADSP-21062s must come out of reset synchronous to CLKIN with program counters (PC) equal (i.e., for a SIMD system). Not required for multiple ADSP-21062s communicating over the shared bus (through the external port), because the bus arbitration logic synchronizes itself automatically after reset.


Figure 9. Reset


## NOTES

${ }^{1}$ Only required for $\overline{\mathrm{IRQx}}$ recognition in the following cycle.
${ }^{2}$ Applies only if $\mathrm{t}_{\text {SIR }}$ and $\mathrm{t}_{\text {HIR }}$ requirements are not met.


Figure 10. Interrupts

## ADSP-21062/ADSP-21062L

|  | ADSP-21062 |  | ADSP-21062L |  |
| :--- | :---: | :---: | :---: | :---: |
| Parameter | Min | Max | Min | Max |



Figure 11. Timer

| Parameter |  | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Max | Min | Max |  |
| Flags |  |  |  |  |  |  |
| Timing Requirements: |  |  |  |  |  |  |
| $\mathrm{t}_{\text {SFI }}$ | FLAG3-0 $0_{\text {IN }}$ Setup Before CLKIN High ${ }^{1}$ | $8+5$ |  | $8+5$ |  | ns |
| $\mathrm{t}_{\mathrm{HFI}}$ | FLAG3-0 IN Hold After CLKIN High ${ }^{1}$ | 0-5 |  | 0-5 |  | ns |
| $\mathrm{t}_{\text {DWRFI }}$ | FLAG3-0 ${ }_{\text {IN }}$ Delay After $\overline{\mathrm{RD}} / \overline{\text { WR }}$ Low ${ }^{1}$ |  | $5+7 \mathrm{DT} / 16$ |  | $5+7 \mathrm{DT} / 16$ | ns |
| $\mathrm{t}_{\text {HFIWR }}$ | FLAG3-0 IN Hold After $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ Deasserted ${ }^{1}$ | 0 |  | 0 |  | ns |
| Switching Characteristics: |  |  |  |  |  |  |
| $\mathrm{t}_{\mathrm{DFO}}$ | FLAG3-0 $0_{\text {OUT }}$ Delay After CLKIN High |  | 16 |  | 16 | ns |
| $\mathrm{t}_{\mathrm{HFO}}$ | FLAG3-0 out Hold After CLKIN High | 4 |  | 4 |  | ns |
| $\mathrm{t}_{\text {DFOE }}$ | CLKIN High to FLAG3-0 out Enable | 3 |  | 3 |  | ns |
| $\mathrm{t}_{\text {DFOD }}$ | CLKIN High to FLAG3-0 ${ }_{\text {out }}$ Disable |  | 14 |  | 14 | ns |

## NOTE

${ }^{1}$ Flag inputs meeting these setup and hold times will affect conditional instructions in the following instruction cycle.


Figure 12. Flags

## ADSP-21062/ADSP-21062L

## Memory Read-Bus Master

Use these specifications for asynchronous interfacing to memories (and memory-mapped peripherals) without reference to CLKIN. These specifications apply when the ADSP-21062 is the bus master accessing external memory space. These switching
characteristics also apply for bus master synchronous read/write timing (see Synchronous Read/Write - Bus Master below). If these timing requirements are met, the synchronous read/write timing can be ignored (and vice versa).

| Parameter | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {DAD }} \quad$ Address, Selects Delay to Data Valid ${ }^{1,4}$ |  | $18+\mathrm{DT}+\mathrm{W}$ |  | $18+\mathrm{DT}+\mathrm{W}$ | ns |
| $\mathrm{t}_{\text {DRLD }} \quad \overline{\mathrm{RD}}$ Low to Data Valid ${ }^{1}$ |  | $12+5 \mathrm{DT} / 8+\mathrm{W}$ |  | $12+5 \mathrm{DT} / 8+\mathrm{W}$ | ns |
| $\mathrm{t}_{\mathrm{HDA}}$ Data Hold from Address, Selects ${ }^{2}$ | 0.5 |  | 0.5 |  | ns |
| $t_{\text {HDR }} \quad$ Data Hold from $\overline{\mathrm{RD}} \mathrm{High}^{2}$ | 2.0 |  | 2.0 |  | ns |
| $t_{\text {DAAK }} \quad$ ACK Delay from Address, Selects ${ }^{3,4}$ |  |  |  | $14+7 \mathrm{DT} / 8+\mathrm{W}$ | ns |
| $t_{\text {DSAK }} \quad$ ACK Delay from $\overline{\mathrm{RD}}$ Low $^{3}$ |  | $8+\mathrm{DT} / 2+\mathrm{W}$ |  | $8+\mathrm{DT} / 2+\mathrm{W}$ | ns |
| Switching Characteristics: |  |  |  |  |  |
| $\mathrm{t}_{\text {DRHA }}$ Address, Selects Hold After $\overline{\mathrm{RD}}$ High | $0+\mathrm{H}$ |  | $0+\mathrm{H}$ |  | ns |
| $\mathrm{t}_{\text {DARL }} \quad$ Address, Selects to $\overline{\mathrm{RD}}$ Low $^{4}$ | $2+3 \mathrm{DT} / 8$ |  | $2+3$ |  | ns |
| $\mathrm{t}_{\mathrm{RW}} \quad \overline{\mathrm{RD}}$ Pulsewidth | $12.5+5 \mathrm{DT} / 8+\mathrm{W}$ |  | $12.5+$ |  | ns |
| $\mathrm{t}_{\text {RWR }} \quad \overline{\mathrm{RD}}$ High to $\overline{\mathrm{WR}}, \overline{\mathrm{RD}}, \overline{\mathrm{DMAG}} \times$ Low | $8+3 \mathrm{DT} / 8+\mathrm{HI}$ |  | $8+3 \mathrm{D}$ |  | ns |
| $\mathrm{t}_{\text {sADADC }}$ Address, Selects Setup Before ADRCLK High ${ }^{4}$ | $0+\mathrm{DT} / 4$ |  | $0+\mathrm{D}$ |  | ns |

$\mathrm{W}=$ (number of wait states specified in WAIT register) $\times \mathrm{t}_{\mathrm{CK}}$.
$\mathrm{HI}=\mathrm{t}_{\mathrm{CK}}$ (if an address hold cycle or bus idle cycle occurs, as specified in WAIT register; otherwise $\mathrm{HI}=0$ ).
$\mathrm{H}=\mathrm{t}_{\mathrm{CK}}$ (if an address hold cycle occurs as specified in WAIT register; otherwise $\mathrm{H}=0$ ).

## NOTES

${ }^{1}$ Data Delay/Setup: User must meet $t_{\text {DAD }}$ or $t_{\text {DRLD }}$ or synchronous spec $t_{\text {SSDATI }}$.
${ }^{2}$ Data Hold: User must meet $\mathrm{t}_{\text {HDA }}$ or $\mathrm{t}_{\text {HDRH }}$ or synchronous spec $\mathrm{t}_{\text {HSDATI }}$. See System Hold Time Calculation under Test Conditions for the calculation of hold times given capacitive and dc loads.
${ }^{3}$ ACK Delay/Setup: User must meet $t_{\text {DAAK }}$ or $t_{\text {DSAK }}$ or synchronous specification $t_{\text {SACKC }}$ for deassertion of ACK (Low), all three specifications must be met for assertion of ACK (High).
${ }^{4}$ The falling edge of $\overline{\mathrm{MS}} \mathrm{x}, \overline{\mathrm{SW}}, \overline{\mathrm{BMS}}$ is referenced.


Figure 13. Memory Read—Bus Master

## ADSP-21062/ADSP-21062L

## Memory Write—Bus Master

Use these specifications for asynchronous interfacing to memories (and memory-mapped peripherals) without reference to CLKIN. These specifications apply when the ADSP-21062 is the bus master accessing external memory space. These switching
characteristics also apply for bus master synchronous read/write timing (see Synchronous Read/Write-Bus Master). If these timing requirements are met, the synchronous read/write timing can be ignored (and vice versa).

| Parameter | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {DAAK }}$ ACK Delay from Address, Selects ${ }^{1,2}$ |  | $14+7 \mathrm{DT} / 8+\mathrm{W}$ |  | $14+7 \mathrm{DT} / 8+\mathrm{W}$ | ns |
| $\mathrm{t}_{\text {DSAK }}$ ACK Delay from $\overline{\mathrm{WR}}$ Low ${ }^{1}$ |  | $8+\mathrm{DT} / 2+\mathrm{W}$ |  | $8+\mathrm{DT} / 2+\mathrm{W}$ | ns |
| Switching Characteristics: |  |  |  |  |  |
| $\mathrm{t}_{\text {DAWH }}$ Address, Selects to $\overline{\mathrm{WR}}$ Deasserted ${ }^{2}$ | $17+$ |  | $17+$ |  | ns |
| $\mathrm{t}_{\text {Dawl }}$ Address, Selects to $\overline{\mathrm{WR}}$ Low $^{2}$ | $3+3$ |  | $3+3$ |  | ns |
| $\mathrm{t}_{\mathrm{ww}} \quad \overline{\mathrm{WR}}$ Pulsewidth | $12+$ |  | $12+$ |  | ns |
| $t_{\text {DDw }}$ Data Setup Before $\overline{\text { WR }}$ High | 7 + D |  | $7+$ D |  | ns |
| $\mathrm{t}_{\text {DWHA }}$ Address Hold After $\overline{\mathrm{WR}}$ Deasserted | $0.5+$ |  | $0.5+$ |  | ns |
| $\mathrm{t}_{\text {DATRWH }}$ Data Disable After $\overline{\mathrm{WR}}$ Deasserted $^{3}$ | $1+\mathrm{D}$ | $6+\mathrm{DT} / 16+\mathrm{H}$ | $1+\mathrm{D}$ | $6+\mathrm{DT} / 16+\mathrm{H}$ | ns |
| $\mathrm{t}_{\text {wwr }} \quad \overline{\mathrm{WR}}$ High to $\overline{\mathrm{WR}}, \overline{\mathrm{RD}}, \overline{\mathrm{DMAG}} \mathrm{x}$ Low | $8+7$ |  | $8+7$ |  | ns |
| $t_{\text {towr }} \quad$ Data Disable Before $\overline{\mathrm{WR}}$ or $\overline{\mathrm{RD}}$ Low | $5+3$ |  | $5+3$ |  | ns |
| $\mathrm{t}_{\text {wDe }} \quad \overline{\mathrm{WR}}$ Low to Data Enabled | $-1+$ |  | -1 + |  | ns |
| $\mathrm{t}_{\text {SADADC }}$ Address, Selects to ADRCLK High ${ }^{2}$ | $0+$ D |  | $0+$ D |  | ns |

$\mathrm{W}=$ (number of wait states specified in WAIT register) $\times \mathrm{t}_{\mathrm{CK}}$.
$\mathrm{H}=\mathrm{t}_{\mathrm{CK}}$ (if an address hold cycle occurs, as specified in WAIT register; otherwise $\mathrm{H}=0$ ).
$\mathrm{I}=\mathrm{t}_{\mathrm{CK}}$ (if a bus idle cycle occurs, as specified in WAIT register; otherwise $\mathrm{I}=0$ ).
NOTES
${ }^{1}$ ACK Delay/Setup: User must meet $t_{\text {DAAK }}$ or $t_{\text {DSAK }}$ or synchronous specification $t_{\text {SACKC }}$ for deassertion of ACK (Low), all three specifications must be met for assertion of ACK (High).
${ }^{2}$ The falling edge of $\overline{\mathrm{MS}} \mathrm{x}, \overline{\mathrm{SW}}, \overline{\mathrm{BMS}}$ is referenced.
${ }^{3}$ See System Hold Time Calculation under Test Conditions for calculation of hold times given capacitive and dc loads.


Figure 14. Memory Write—Bus Master

## ADSP-21062/ADSP-21062L

## Synchronous Read/Write-Bus Master

Use these specifications for interfacing to external memory systems that require CLKIN-relative timing or for accessing a slave ADSP-21062 (in multiprocessor memory space). These synchronous switching characteristics are also valid during asynchronous memory reads and writes (see Memory Read-Bus Master and Memory Write-Bus Master).

When accessing a slave ADSP-21062, these switching characteristics must meet the slave's timing requirements for synchronous read/writes (see Synchronous Read/Write-Bus Slave). The slave ADSP-21062 must also meet these (bus master) timing requirements for data and acknowledge setup and hold times.

| Parameter | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {sSDati }}$ Data Setup Before CLKIN | $3+\mathrm{DT} / 8$ |  | $3+\mathrm{DT} / 8$ |  | ns |
| $\mathrm{t}_{\text {HSDati }}$ Data Hold After CLKIN | 3.5 - DT/8 |  | 3.5 - DT/8 |  | ns |
| $\begin{array}{ll}t_{\text {DAAK }} & \text { ACK Delay After Address, } \overline{\mathrm{MS}} \mathrm{x} \text {, } \\ \overline{\mathrm{SW}}, \overline{\mathrm{BMS}^{1,2}}\end{array}$ |  | $14+7 \mathrm{DT} / 8+\mathrm{W}$ |  | $14+7 \mathrm{DT} / 8+\mathrm{W}$ | ns |
| $\mathrm{t}_{\text {SACKC }}$ ACK Setup Before CLKIN ${ }^{2}$ | $6.5+\mathrm{DT} / 4$ |  | $6.5+\mathrm{DT} / 4$ |  | ns |
| $\mathrm{t}_{\mathrm{HACK}}$ ACK Hold After CLKIN | -1-DT/4 |  | -1-DT/4 |  | ns |
| Switching Characteristics: |  |  |  |  |  |
| $\mathrm{t}_{\text {DADRo }}$ Address, $\overline{\mathrm{MS}} \mathrm{x}, \overline{\mathrm{BMS}}, \overline{\mathrm{SW}}$ Delay After CLKIN ${ }^{1}$ $\qquad$ |  | 7 - DT/8 |  | 7 - DT/8 | ns |
| $\mathrm{t}_{\text {Hadro }}$ Address, $\overline{\mathrm{MS}} \mathrm{x}, \overline{\mathrm{BMS}}, \overline{\mathrm{SW}}$ Hold After CLKIN | -1-DT/8 |  | -1-DT/8 |  | ns |
| $\mathrm{t}_{\text {DPGG }}$ PAGE Delay After CLKIN | $9+\mathrm{DT} / 8$ | $16+\mathrm{DT} / 8$ | $9+\mathrm{DT} / 8$ | $16+\mathrm{DT} / 8$ | ns |
| $\mathrm{t}_{\mathrm{DRDO}} \quad \overline{\mathrm{RD}}$ High Delay After CLKIN | -2-DT/8 | $4-\mathrm{DT} / 8$ | -2-DT/8 | $4-\mathrm{DT} / 8$ | ns |
| $\mathrm{t}_{\text {Dwro }} \quad \overline{\mathrm{WR}}$ High Delay After CLKIN | -3-3DT/16 | 4-3DT/16 | -3-3DT/16 | 4-3DT/16 | ns |
| $\mathrm{t}_{\text {DRWL }} \overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ Low Delay After CLKIN | $8+\mathrm{DT} / 4$ | $12.5+\mathrm{DT} / 4$ | $8+\mathrm{DT} / 4$ | $12.5+\mathrm{DT} / 4$ | ns |
| $t_{\text {sddato }}$ Data Delay After CLKIN |  | $19+5 \mathrm{DT} / 16$ |  | $19+5 \mathrm{DT} / 16$ | ns |
| $\mathrm{t}_{\text {Dattr }}$ Data Disable After CLKIN ${ }^{3}$ | $0-\mathrm{DT} / 8$ | 7 - DT/8 | $0-\mathrm{DT} / 8$ | 7 - DT/8 | ns |
| $\mathrm{t}_{\text {Dadcck }}$ ADRCLK Delay After CLKIN | $4+\mathrm{DT} / 8$ | $10+\mathrm{DT} / 8$ | $4+\mathrm{DT} / 8$ | $10+\mathrm{DT} / 8$ | ns |
| $\mathrm{t}_{\text {Adrck }}$ ADRCLK Period | $\mathrm{t}_{\mathrm{CK}}$ |  | $\mathrm{t}_{\mathrm{CK}}$ |  | ns |
| $\mathrm{t}_{\text {Adrckh }}$ ADRCLK Width High | ( $\mathrm{t}_{\mathrm{CK}} / 2-2$ ) |  | $\left(\mathrm{t}_{\mathrm{CK}} / 2-2\right)$ |  | ns |
| $\mathrm{t}_{\text {Adrckl }}$ ADRCLK Width Low | ( $\mathrm{t}_{\mathrm{CK}} / 2-2$ ) |  | $\left(\mathrm{t}_{\mathrm{CK}} / 2-2\right)$ |  | ns |

$\mathrm{W}=\left(\right.$ number of Wait states specified in WAIT register) $\times \mathrm{t}_{\mathrm{CK}}$.
NOTES
${ }^{1}$ The falling edge of $\overline{\mathrm{MS}}, \overline{\mathrm{SW}}, \overline{\mathrm{BMS}}$ is referenced.
${ }^{2}$ ACK Delay/Setup: User must meet $\mathrm{t}_{\text {DAAK }}$ or $\mathrm{t}_{\mathrm{DSAK}}$ or synchronous specification $\mathrm{t}_{\text {SACKC }}$ for deassertion of ACK (Low), all three specifications must be met for assertion of ACK (High).
${ }^{3}$ See System Hold Time Calculation under Test Conditions for calculation of hold times given capacitive and dc loads.

## ADSP-21062/ADSP-21062L



Figure 15. Synchronous Read/Write—Bus Master

## ADSP-21062/ADSP-21062L

## Synchronous Read/Write—Bus Slave

Use these specifications for ADSP-21062 bus master accesses of a slave's IOP registers or internal memory (in multiprocessor
memory space). The bus master must meet these (bus slave) timing requirements.

| Parameter | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {SADRI }} \quad$ Address, $\overline{\text { SW }}$ Setup Before CLKIN | $15+\mathrm{DT} / 2$ |  | $15+\mathrm{DT} / 2$ |  | ns |
| $\mathrm{t}_{\text {HADRI }}$ Address, $\overline{\text { SW }}$ Hold Before CLKIN |  | $5+\mathrm{DT} / 2$ |  | $5+\mathrm{DT} / 2$ | ns |
| $\mathrm{t}_{\text {SRWLI }} \quad \overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ Low Setup Before CLKIN ${ }^{1}$ | $9.5+5 \mathrm{DT} / 16$ |  | $9.5+5 \mathrm{DT} / 16$ |  | ns |
| $\mathrm{t}_{\text {HRWLI }} \quad \overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ Low Hold After CLKIN | -4-5DT/16 | $8+7 \mathrm{DT} / 16$ | -4-5DT/16 | $8+7 \mathrm{DT} / 16$ | ns |
| $\mathrm{t}_{\text {RWHPI }} \quad \overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ Pulse High | 3 |  | 3 |  | ns |
| $\mathrm{t}_{\text {SDatwh }}$ Data Setup Before $\overline{\mathrm{WR}}$ High | 5 |  | 5 |  | ns |
| $t_{\text {HDatwh }}$ Data Hold After WR High | 1 |  | 1 |  | ns |
| Switching Characteristics: |  |  |  |  |  |
| $\mathrm{t}_{\text {SDDato }}$ Data Delay After CLKIN |  | $19+5 \mathrm{DT} / 16$ |  | $19+5 \mathrm{DT} / 16$ | ns |
| $\mathrm{t}_{\text {Dattr }} \quad$ Data Disable After CLKIN ${ }^{2}$ | $0-\mathrm{DT} / 8$ | 7 - DT/8 | $0-\mathrm{DT} / 8$ | 7 - DT/8 | ns |
| $\mathrm{t}_{\text {DACKAD }} \quad$ ACK Delay After Address, $\overline{\text { SW }}^{3}$ |  | 9 |  | 9 | ns |
| $\mathrm{t}_{\text {ACKTR }} \quad$ ACK Disable After CLKIN ${ }^{3}$ | -1-DT/8 | 6 - DT/8 | -1-DT/8 | 6 - DT/8 | ns |

## NOTES

${ }^{1}$ t $_{\text {SRWLI }}(\mathrm{min})=9.5+5 \mathrm{DT} / 16$ when Multiprocessor Memory Space Wait State (MMSWS bit in WAIT register) is disabled; when MMSWS is enabled, $\mathrm{t}_{\text {SRWLI }}(\mathrm{min})$ $=4+\mathrm{DT} / 8$.
${ }^{2}$ See System Hold Time Calculation under Test Conditions for calculation of hold times given capacitive and dc loads.
${ }^{3} \mathrm{t}_{\text {DACKAD }}$ is true only if the address and $\overline{\text { SW }}$ inputs have setup times (before CLKIN) greater than $10+\mathrm{DT} / 8$ and less than $19+3 \mathrm{DT} / 4$. If the address and $\overline{\text { SW }}$ inputs have setup times greater than $19+3 \mathrm{DT} / 4$, then ACK is valid $14+\mathrm{DT} / 4$ (max) after CLKIN. A slave that sees an address with an M field match will respond with ACK regardless of the state of MMSWS or strobes. A slave will three-state ACK every cycle with $\mathrm{t}_{\text {ACKTR }}$.


Figure 16. Synchronous Read/Write—Bus Slave

## ADSP-21062/ADSP-21062L

Multiprocessor Bus Request and Host Bus Request
Use these specifications for passing of bus mastership between
multiprocessing ADSP-21062s ( $\overline{\mathrm{BR}} \mathrm{x}$ ) or a host processor
( $\overline{\mathrm{HBR}}, \overline{\mathrm{HBG}})$.

| Parameter | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {HBGRCsv }} \overline{\text { HBG }}$ Low to $\overline{\mathrm{RD}} / \overline{\mathrm{WR}} / \overline{\mathrm{CS}}$ Valid $^{1}$ |  | $20+5 \mathrm{DT} / 4$ |  | $20+5 \mathrm{DT} / 4$ | ns |
| $\mathrm{t}_{\text {SHBRI }} \quad \overline{\text { HBR }}$ Setup Before CLKIN ${ }^{2}$ | $20+3 \mathrm{DT} / 4$ |  | $20+3 \mathrm{DT} / 4$ |  | ns |
| $\mathrm{t}_{\text {Hhbri }} \quad \overline{\text { HBR }}$ Hold Before CLKIN ${ }^{2}$ |  | $14+3 \mathrm{DT} / 4$ |  | $14+3 \mathrm{DT} / 4$ | ns |
| $\mathrm{t}_{\text {SHBGI }} \quad \overline{\text { HBG }}$ Setup Before CLKIN | $13+\mathrm{DT} / 2$ |  | $13+\mathrm{DT} / 2$ |  | ns |
| $\mathrm{t}_{\text {HHBGI }} \quad \overline{\text { HBG }}$ Hold Before CLKIN High |  | $6+\mathrm{DT} / 2$ |  | $6+\mathrm{DT} / 2$ | ns |
| $\mathrm{t}_{\text {SBRI }} \quad \overline{\mathrm{BR}} \mathrm{x}, \overline{\mathrm{CPA}}$ Setup Before CLKIN ${ }^{3}$ | $13+\mathrm{DT} / 2$ |  | $13+\mathrm{DT} / 2$ |  | ns |
| $\mathrm{t}_{\mathrm{HBRI}} \quad \overline{\mathrm{BRx}}, \overline{\mathrm{CPA}}$ Hold Before CLKIN High |  | $6+\mathrm{DT} / 2$ |  | $6+\mathrm{DT} / 2$ | ns |
| $\mathrm{t}_{\text {SRPBAI }}$ RPBA Setup Before CLKIN | $21+3 \mathrm{DT} / 4$ |  | $21+3 \mathrm{DT} / 4$ |  | ns |
| $\mathrm{t}_{\text {HRPbai }}$ RPBA Hold Before CLKIN |  | $12+3 \mathrm{DT} / 4$ |  | $12+3 \mathrm{DT} / 4$ | ns |
| Switching Characteristics: |  |  |  |  |  |
| $\mathrm{t}_{\text {DHBGO }} \quad \overline{\text { HBG }}$ Delay After CLKIN |  | 7 - DT/8 |  | 7 - DT/8 | ns |
| $\mathrm{t}_{\text {HHBGO }} \quad \overline{\mathrm{HBG}}$ Hold After CLKIN | -2-DT/8 |  | -2-DT/8 |  | ns |
| $\mathrm{t}_{\text {DBRO }} \quad \overline{\mathrm{BRx}}$ Delay After CLKIN |  | 7 - DT/8 |  | 7 - DT/8 | ns |
| $\mathrm{t}_{\text {HBRO }} \quad \overline{\mathrm{BR}} \mathrm{x}$ Hold After CLKIN | -2-DT/8 |  | -2-DT/8 |  | ns |
| $\mathrm{t}_{\text {DCPAO }} \quad \overline{\mathrm{CPA}}$ Low Delay After CLKIN |  | $8-\mathrm{DT} / 8$ |  | $8-\mathrm{DT} / 8$ | ns |
| $\mathrm{t}_{\text {TRCPA }} \quad \overline{\mathrm{CPA}}$ Disable After CLKIN | -2-DT/8 | 4.5 - DT/8 | -2-DT/8 | 4.5 - DT/8 | ns |
| $\begin{array}{ll}\text { t }_{\text {DRDYCS }} & \text { REDY (O/D) or (A/D) Low from } \overline{\mathrm{CS}} \\ \text { and } \overline{\mathrm{HBR}} \mathrm{Low}^{4}\end{array}$ |  | 8.5 |  | 8.75 | ns |
| $\mathrm{t}_{\text {TRDYHG }} \quad$ REDY (O/D) Disable or REDY (A/D) High from $\overline{\mathrm{HBG}}^{4}$ | $44+23 \mathrm{DT} / 16$ |  | $44+23 \mathrm{DT} / 16$ |  | ns |
| $\mathrm{t}_{\text {ARDYTR }} \quad \frac{\mathrm{REDY}}{\mathrm{HBR}} \mathrm{High}^{4}$ ) Disable from $\overline{\mathrm{CS}}$ or $\overline{\mathrm{HBR}} \mathrm{High}^{4}$ |  | 10 |  | 10 | ns |

NOTES
${ }^{1}$ For first asynchronous access after $\overline{\mathrm{HBR}}$ and $\overline{\mathrm{CS}}$ asserted, $\mathrm{ADDR}_{31-0}$ must be a non-MMS value $1 / 2 \mathrm{t}_{\mathrm{CK}}$ before $\overline{\mathrm{RD}}$ or $\overline{\mathrm{WR}}$ goes low or by $\mathrm{t}_{\text {HBGRCsv }}$ after $\overline{\mathrm{HBG}}$ goes low. This is easily accomplished by driving an upper address signal high when $\overline{\mathrm{HBG}}$ is asserted. See the "Host Processor Control of the ADSP-21062" section in the ADSP-21062 SHARC User's Manual, Second Edition.
${ }^{2}$ Only required for recognition in the current cycle.
${ }^{3} \overline{\mathrm{CPA}}$ assertion must meet the setup to CLKIN; deassertion does not need to meet the setup to CLKIN.
${ }^{4}(O / D)=$ open drain, $(A / D)=$ active drive.


Figure 17. Multiprocessor Bus Request and Host Bus Request

## ADSP-21062/ADSP-21062L

Asynchronous Read/Write-Host to ADSP-21062
Use these specifications for asynchronous host processor accesses of an ADSP-21062, after the host has asserted $\overline{\mathrm{CS}}$ and $\overline{\mathrm{HBR}}$ (low). After $\overline{\mathrm{HBG}}$ is returned by the ADSP-21062, the host can
drive the $\overline{\mathrm{RD}}$ and $\overline{\mathrm{WR}}$ pins to access the ADSP-21062's internal memory or IOP registers. $\overline{\mathrm{HBR}}$ and $\overline{\mathrm{HBG}}$ are assumed low for this timing.

| Parameter |  | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Max | Min | Max |  |
| Read Cycle |  |  |  |  |  |  |
| Timing Requirements: |  |  |  |  |  |  |
| $\mathrm{t}_{\text {SADRDL }}$ | Address Setup/ $\overline{\mathrm{CS}}$ Low Before $\overline{\mathrm{RD}}$ Low ${ }^{1}$ | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {Hadrd }}$ | Address Hold/ $\overline{\mathrm{CS}}$ Hold Low After $\overline{\mathrm{RD}}$ | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {WRWH }}$ | $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ High Width | 6 |  | 6 |  | ns |
| $\mathrm{t}_{\text {DRDHRDY }}$ | $\overline{\mathrm{RD}}$ High Delay After REDY (O/D) Disable | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {DRDHRDY }}$ | $\overline{\mathrm{RD}}$ High Delay After REDY (A/D) Disable | 0 |  | 0 |  | ns |
| Switching Characteristics: |  |  |  |  |  |  |
| $\mathrm{t}_{\text {SDATRDY }}$ | Data Valid Before REDY Disable from Low | 2 |  | 2 |  | ns |
| $\mathrm{t}_{\text {DRDYRDL }}$ | REDY (O/D) or (A/D) Low Delay After $\overline{\mathrm{RD}}$ Low |  | 10 |  | 10 | ns |
| $\mathrm{t}_{\text {RDYPRD }}$ | REDY (O/D) or (A/D) Low Pulse |  |  |  |  |  |
|  | Width for Read | $45+21 \mathrm{DT} / 16$ |  | $45+21 \mathrm{DT} / 16$ |  | ns |
| $\mathrm{t}_{\text {HDARWH }}$ | Data Disable After $\overline{\mathrm{RD}}$ High |  | 8 |  | 8 | ns |
| Write Cycle |  |  |  |  |  |  |
| Timing Requirements: |  |  |  |  |  |  |
| $\mathrm{t}_{\text {SCSWRL }}$ | $\overline{\mathrm{CS}}$ Low Setup Before $\overline{\mathrm{WR}}$ low | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {HCSWR }}$ | $\overline{\mathrm{CS}}$ Low Hold After $\overline{\mathrm{WR}}$ high | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {SADWRH }}$ | Address Setup Before WR High | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {HADWRH }}$ | Address Hold After WR High | 2 |  | 2 |  | ns |
| $\mathrm{t}_{\mathrm{WWWRL}}$ | WR Low Width | 7 |  | 7 |  | ns |
| $\mathrm{t}_{\text {WRWH }}$ | $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ High Width | 6 |  | 6 |  | ns |
| $\mathrm{t}_{\text {DWRHRDY }}$ | $\overline{\text { WR }}$ High Delay After REDY |  |  |  |  |  |
|  | (O/D) or (A/D) Disable | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {SDATWH }}$ | Data Setup Before WR High | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {HDATWH }}$ | Data Hold After WR High | 1 |  | 1 |  | ns |
| Switching Characteristics: |  |  |  |  |  |  |
| $\mathrm{t}_{\mathrm{DRDYWRL}}$ | REDY (O/D) or (A/D) Low Delay After $\overline{\mathrm{WR}} / \overline{\mathrm{CS}}$ Low |  | 10 |  | 10 | ns |
| $\mathrm{t}_{\text {RDYPWR }}$ | REDY (O/D) or (A/D) Low Pulse Width for Write | $15+7 \mathrm{DT} / 16$ |  | $15+7 \mathrm{DT} / 16$ |  | ns |
| $\underline{t_{\text {SRDYCK }}}$ | REDY (O/D) or (A/D) Disable to CLKIN | $1+7 \mathrm{DT} / 16$ | $8+7 \mathrm{DT} / 16$ | $1+7 \mathrm{DT} / 16$ | $8+7 \mathrm{DT} / 16$ | ns |

## NOTE

${ }^{1}$ Not required if $\overline{\mathrm{RD}}$ and address are valid $\mathrm{t}_{\mathrm{HBGRCSv}}$ after $\overline{\mathrm{HBG}}$ goes low. For first access after $\overline{\mathrm{HBR}}$ asserted, $\mathrm{ADDR}_{31-0}$ must be a non-MMS value $1 / 2 \mathrm{t}_{\mathrm{CLK}}$ before $\overline{\mathrm{RD}}$ or $\overline{\mathrm{WR}}$ goes low or by $\mathrm{t}_{\mathrm{HbGRCsv}}$ after $\overline{\mathrm{HBG}}$ goes low. This is easily accomplished by driving an upper address signal high when $\overline{\mathrm{HBG}}$ is asserted. See the "Host Processor Control of the ADSP-21062" section in the ADSP-21062 SHARC User's Manual, Second Edition.


O/D = OPEN DRAIN, A/D = ACTIVE DRIVE
Figure 18a. Synchronous REDY Timing


Figure 18b. Asynchronous Read/Write—Host to ADSP-21062

## ADSP-21062/ADSP-21062L

Three-State Timing-Bus Master, Bus Slave, $\overline{\text { HBR }}, \overline{\text { SBTS }}$
These specifications show how the memory interface is disabled (stops driving) or enabled (resumes driving) relative to CLKIN
and the $\overline{\text { SBTS }}$ pin. This timing is applicable to bus master transition cycles (BTC) and host transition cycles (HTC) as well as the $\overline{\text { SBTS }}$ pin.

| Parameter | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {STSCK }} \quad \overline{\text { SBTS }}$ Setup Before CLKIN | $12+\mathrm{DT} / 2$ |  | $12+\mathrm{DT} / 2$ |  | ns |
| $\mathrm{t}_{\text {HTSCK }} \quad \overline{\text { SBTS }}$ Hold Before CLKIN |  | $6+\mathrm{DT} / 2$ |  | $6+\mathrm{DT} / 2$ | ns |
| Switching Characteristics: |  |  |  |  |  |
| $\mathrm{t}_{\text {miena }}$ Address/Select Enable After CLKIN | -1-DT/8 |  | -1.25-DT/8 |  | ns |
| $\mathrm{t}_{\text {miens }} \quad$ Strobes Enable After CLKIN ${ }^{1}$ | -1.5-DT/8 |  | -1.5-DT/8 |  | ns |
| $\mathrm{t}_{\text {mienhg }} \quad \overline{\text { HBG }}$ Enable After CLKIN | -1.5-DT/8 |  | -1.5-DT/8 |  | ns |
| $\mathrm{t}_{\text {MITRA }}$ Address/Select Disable After CLKIN |  | $0-\mathrm{DT} / 4$ |  | $0-\mathrm{DT} / 4$ | ns |
| $\mathrm{t}_{\text {MITRS }} \quad$ Strobes Disable After CLKIN ${ }^{1}$ |  | 1.5 - DT/4 |  | 1.5 - DT/4 | ns |
| $\mathrm{t}_{\text {mitrhg }} \quad \overline{\text { HBG }}$ Disable After CLKIN |  | 2.0 - DT/4 |  | 2.0 - DT/4 | ns |
| $\mathrm{t}_{\text {daten }}$ Data Enable After CLKIN ${ }^{2}$ | $9+5 \mathrm{DT} / 16$ |  | $9+5 \mathrm{DT} / 16$ |  | ns |
| $\mathrm{t}_{\text {Dattr }}$ Data Disable After CLKIN ${ }^{2}$ | $0-\mathrm{DT} / 8$ | 7 - DT/8 | -0.5-DT/8 | 7 - DT/8 | ns |
| $\mathrm{t}_{\text {ACKEN }}$ ACK Enable After CLKIN ${ }^{2}$ | $7.5+$ DT/4 |  | $7.5+$ DT/4 |  | ns |
| $\mathrm{t}_{\text {ACKTR }} \quad$ ACK Disable After CLKIN ${ }^{2}$ | -1-DT/8 | 6 - DT/8 | -1-DT/8 | 6 - DT/8 | ns |
| $\mathrm{t}_{\text {ADCEN }}$ ADRCLK Enable After CLKIN | -2-DT/8 |  | -2-DT/8 |  | ns |
| $\mathrm{t}_{\text {ADCTR }}$ ADRCLK Disable After CLKIN |  | $8-\mathrm{DT} / 4$ |  | $8-\mathrm{DT} / 4$ | ns |
| $\begin{array}{ll}\mathrm{t}_{\text {MTRHBG }} & \text { Memory Interface Disable Before } \\ \overline{\mathrm{HBG}} \mathrm{Low}^{3}\end{array}$ | 0 + DT/8 |  | 0 + DT/8 |  | ns |
| $\mathrm{t}_{\text {menhbg }} \quad$ Memory Interface Enable After HBG $\mathrm{High}^{3}$ | $19+$ DT |  | $19+$ DT |  | ns |

## NOTES

${ }^{1}$ Strobes $=\overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \overline{\mathrm{SW}}$, PAGE,$\overline{\mathrm{DMAG}}$.
${ }^{2}$ In addition to bus master transition cycles, these specs also apply to bus master and bus slave synchronous read/write.
${ }^{3}$ Memory Interface $=$ Address $\overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \overline{\mathrm{MS}} \mathrm{x}, \overline{\mathrm{SW}}$, PAGE, $\overline{\mathrm{DMAG}} \mathrm{x}, \overline{\mathrm{BMS}}$ (in EPROM boot mode).


Figure 19a. Three-State Timing (Bus Transition Cycle, $\overline{S B T S}$ Assertion)


MEMORY INTERFACE = ADDRESS, $\overline{R D}, \overline{W R}, \overline{M S x}, \overline{S W}$, PAGE, $\overline{\text { DMAGx }}$. $\overline{\text { BMS }}$ (IN EPROM BOOT MODE)
Figure 19b. Three-State Timing (Host Transition Cycle)
REV. B

## ADSP-21062/ADSP-21062L

## DMA Handshake

These specifications describe the three DMA handshake modes. In all three modes DMAR is used to initiate transfers. For handshake mode, DMAG controls the latching or enabling of data externally. For external handshake mode, the data transfer is controlled by the $\mathrm{ADDR}_{31-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \overline{\mathrm{SW}}, \mathrm{PAGE}, \overline{\mathrm{MS}}_{3-0}$, ACK, and $\overline{\text { DMAG }}$ signals. For Paced Master mode, the data
transfer is controlled by ADDR31-0, $\overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \overline{\mathrm{MS}}_{3-0}$, and ACK (not $\overline{\text { DMAG }}$ ). For Paced Master mode, the Memory Read-Bus Master, Memory Write-Bus Master, and Synchronous Read/ Write-Bus Master timing specifications for $\mathrm{ADDR}_{31-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}$, $\overline{\mathrm{MS}}_{3-0}, \overline{\mathrm{SW}}$, PAGE, DATA47-0, and ACK also apply.


[^2]
## ADSP-21062/ADSP-21062L


*MEMORY READ - BUS MASTER, MEMORY WRITE - BUS MASTER, AND SYNCHRONOUS READ/WRITE - BUS MASTER TIMING SPECIFICATIONS FOR ADDR $3_{11-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \overline{\mathrm{SW}}, \overline{\mathrm{MS}}_{3-0}$ AND ACK ALSO APPLY HERE.

Figure 20. DMA Handshake Timing

Link Ports: $1 \times$ CLK Speed Operation


## NOTES

${ }^{1}$ LACK will go low with $t_{\text {DLALC }}$ relative to rising edge of LCLK after first nibble is received. LACK will not go low if the receiver's link buffer is not about to fill. ${ }^{2}$ Only required for interrupt recognition in the current cycle.

## ADSP-21062/ADSP-21062L

## Link Ports: $2 \times$ CLK Speed Operation

Calculation of link receiver data setup and hold relative to link clock is required to determine the maximum allowable skew that can be introduced in the transmission path between LDATA and LCLK. Setup skew is the maximum delay that can be introduced in LDATA relative to LCLK, (setup skew $=$ t $_{\text {LCLKTw }}$ $\mathrm{min}-\mathrm{t}_{\text {DLDCH }}-\mathrm{t}_{\text {SLDCL }}$ ). Hold skew is the maximum delay that can be introduced in LCLK relative to LDATA, (hold skew $=$ $\mathrm{t}_{\text {LCLKTwL }} \min -\mathrm{t}_{\text {HLDCH }}-\mathrm{t}_{\text {HLDCL }}$ ). Calculations made directly
from $2 \times$ speed specifications will result in unrealistically small skew times because they include multiple tester guardbands. The setup and hold skew times shown below are calculated to include only one tester guardband.

| ADSP-21062 Setup Skew | 1.84 ns max |
| :---: | :---: |
| ADSP-21062 Hold Skew | 2.78 ns max |
| ADSP-21062L Setup Skew ADSP-21062L Hold Skew | $\begin{aligned} & =2.10 \mathrm{~ns} \max \\ & =1.87 \mathrm{~ns} \max \end{aligned}$ |


|  | $\begin{array}{c}\text { ADSP-21062 } \\ \text { Max }\end{array}$ |  | ADSP-21062L |  |
| :--- | :--- | :--- | :--- | :--- |
| Max |  |  |  |  |$)$

[^3]

LINK PORT ENABLE/THREE-STATE DELAY FROM INSTRUCTION


LINK PORT ENABLE OR THREE-STATE TAKES EFFECT TWO CYCLES AFTER A WRITE TO A LINK PORT CONTROL REGISTER.

LINK PORT INTERRUPT SETUP TIME


Figure 21. Link Ports

## Serial Ports

| Parameter | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |  |
| External Clock |  |  |  |  |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {SFSE }} \quad$ TFS/RFS Setup Before TCLK/RCLK ${ }^{1}$ | 3.5 |  | 3.5 |  | ns |
| $\mathrm{t}_{\text {HFSE }} \quad$ TFS/RFS Hold After TCLK/RCLK ${ }^{1,2}$ | 4 |  | 4 |  | ns |
| $\mathrm{t}_{\text {SDRE }} \quad$ Receive Data Setup Before RCLK ${ }^{1}$ | 1.5 |  | 1.5 |  | ns |
| $\mathrm{t}_{\text {HDRe }} \quad$ Receive Data Hold After RCLK ${ }^{1}$ | 4 |  | 4 |  | ns |
| $\mathrm{t}_{\text {scLkw }}$ TCLK/RCLK Width | 9 |  | 9 |  | ns |
| $\mathrm{t}_{\text {SCLK }}$ TCLK/RCLK Period | $\mathrm{t}_{\mathrm{CK}}$ |  | $\mathrm{t}_{\mathrm{CK}}$ |  | ns |
| Internal Clock |  |  |  |  |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {SFSI }} \quad$ TFS Setup Before TCLK $^{1}$; RFS Setup | 8 |  | 8 |  | ns |
| $\mathrm{t}_{\mathrm{HFSI}} \quad \mathrm{TFS} / \mathrm{RFS}$ Hold After TCLK/RCLK ${ }^{1,2}$ | 1 |  | 1 |  | ns |
| $\mathrm{t}_{\text {SDRI }} \quad$ Receive Data Setup Before RCLK ${ }^{1}$ | 3 |  | 3 |  | ns |
| $\mathrm{t}_{\mathrm{HDRI}} \quad$ Receive Data Hold After RCLK ${ }^{1}$ | 3 |  | 3 |  | ns |
| External or Internal Clock Switching Characteristics: |  |  |  |  |  |
| $\begin{array}{ll}\mathrm{t}_{\text {DFSE }} & \text { RFS Delay After RCLK (Internally } \\ \text { Generated RFS) }\end{array}$ |  | 13 |  | 13 | ns |
| $\mathrm{t}_{\text {Hofse }} \quad \begin{aligned} & \text { RFS Hold After RCLK (Internally } \\ & \\ & \text { Generated RFS) }\end{aligned}$ | 3 |  | 3 |  | ns |
| Switching Characteristics: |  |  |  |  |  |
| $\begin{array}{ll}\mathrm{t}_{\text {DFSE }} & \text { TFS Delay After TCLK (Internally } \\ & \text { Generated TFS) }\end{array}$ |  | 13 |  | 13 | ns |
| $\begin{array}{ll}\mathrm{t}_{\text {Hofse }} & \text { TFS Hold After TCLK (Internally } \\ & \text { Generated TFS) }\end{array}$ | 3 |  | 3 |  | ns |
| $\mathrm{t}_{\text {dDte }} \quad$ Transmit Data Delay After TCLK ${ }^{3}$ |  | 16 |  | 16 | ns |
| $\mathrm{t}_{\text {HDTE }} \quad$ Transmit Data Hold After TCLK ${ }^{3}$ | 5 |  | 5 |  | ns |
| Internal Clock <br> Switching Characteristics: |  |  |  |  |  |
| $\begin{array}{ll}\text { t }_{\text {DFSI }} & \text { TFS Delay After TCLK (Internally } \\ & \text { Generated TFS) }\end{array}$ |  | 4.5 |  | 4.5 | ns |
| $\begin{array}{ll}\mathrm{t}_{\text {HoFsi }} & \text { TFS Hold After TCLK (Internally } \\ & \text { Generated TFS) }\end{array}$ | -1.5 |  | -1.5 |  | ns |
| $\mathrm{t}_{\mathrm{DDTI}} \quad$ Transmit Data Delay After TCLK ${ }^{3}$ |  | 7.5 |  | 7.5 | , |
| $\mathrm{t}_{\mathrm{HDTI}} \quad$ Transmit Data Hold After $\mathrm{TCLK}^{3}$ |  |  |  |  | ns |
| $\mathrm{t}_{\text {sCLKIW }}$ TCLK/RCLK Width | $\left(\mathrm{t}_{\text {SCLK }} / 2\right)-2.5$ | $\left(\mathrm{t}_{\text {SCLK }} / 2\right)+2.5$ | $\left(\mathrm{t}_{\text {SCLK }} / 2\right)-2.5$ | $\left(\mathrm{t}_{\text {SCLK }} / 2\right)+2.5$ | ns |
| Enable and Three-State |  |  |  |  |  |
| $\mathrm{t}_{\text {DDTEN }}$ Data Enable from External TCLK ${ }^{3}$ | 4.25 |  | 4 |  | ns |
| $\mathrm{t}_{\text {DDTTE }} \quad$ Data Disable from External TCLK $^{3}$ |  | 10.5 |  | 16 | ns |
| $\mathrm{t}_{\text {DDTIN }}$ Data Enable from Internal TCLK ${ }^{3}$ | 0 |  | 0 |  | ns |
| $\mathrm{t}_{\text {DDTTI }}$ Data Disable from Internal TCLK ${ }^{3}$ |  | 3 |  | 7.5 | ns |
| $\mathrm{t}_{\text {DCLK }}$ TCLK/RCLK Delay from CLKIN |  | $22+3 \mathrm{DT} / 8$ |  | $22+3 \mathrm{DT} / 8$ | ns |
| $\mathrm{t}_{\text {DPTR }} \quad$ SPORT Disable After CLKIN |  | 17 |  | 17 | ns |
| Gated SCLK with External TFS (Mesh Multiprocessing) ${ }^{4}$ <br> Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {STFSCK }}$ TFS Setup Before CLKIN | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {HTfsck }}$ TFS Hold After CLKIN | $\mathrm{t}_{\mathrm{CK}} / 2$ |  | $\mathrm{t}_{\mathrm{CK}} / 2$ |  | ns |
| External Late Frame Sync <br> Switching Characteristics: <br> $\mathrm{t}_{\text {DDtlfse }}$ Data Delay from Late External TFS or External RFS with MCE $=1, \mathrm{MFD}=0^{5}$ |  | 12.75 |  | 12.75 | ns |
| $t_{\text {DDTENFS }}$ Data Enable from late FS or MCE $=1$, $\mathrm{MFD}=0^{5}$ | 3.5 |  | 3.5 |  | ns |

To determine whether communication is possible between two devices at clock speed $n$, the following specifications must be confirmed: 1 ) frame sync delay and frame sync setup and hold, 2) data delay and data setup and hold, and 3) SCLK width.

NOTES
${ }^{1}$ Referenced to sample edge.
${ }^{2}$ RFS hold after RCK when MCE $=1, \mathrm{MFD}=0$ is 0 ns minimum from drive edge. TFS hold after TCK for late external TFS is 0 ns minimum from drive edge.
${ }^{3}$ Referenced to drive edge.
${ }^{4}$ Applies only to gated serial clock mode used for serial port system I/O in mesh multiprocessing systems.
${ }^{5} \mathrm{MCE}=1$, TFS enable and TFS valid follow $\mathrm{t}_{\text {DDTLFSE }}$ and $\mathrm{t}_{\text {DDTENFs }}$.


NOTE: EITHER THE RISING EDGE OR FALLING EDGE OF RCLK, TCLK CAN BE USED AS THE ACTIVE SAMPLING EDGE.


NOTE: EITHER THE RISING EDGE OR FALLING EDGE OF RCLK, TCLK CAN BE USED AS THE ACTIVE SAMPLING EDGE.


Figure 22. Serial Ports

## ADSP-21062/ADSP-21062L



Figure 23. External Late Frame Sync

## ADSP-21062/ADSP-21062L

JTAG Test Access Port and Emulation

| Parameter | ADSP-21062 |  | ADSP-21062L |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |  |
| Timing Requirements: |  |  |  |  |  |
| $\mathrm{t}_{\text {TCK }} \quad$ TCK Period | $\mathrm{t}_{\text {CK }}$ |  | $\mathrm{t}_{\text {CK }}$ |  | ns |
| $\mathrm{t}_{\text {STAP }} \quad$ TDI, TMS Setup Before TCK High | 5 |  | 5 |  | ns |
| $\mathrm{t}_{\text {HTAP }} \quad$ TDI, TMS Hold After TCK High | 6 |  | 6 |  | ns |
| $\mathrm{t}_{\text {SSYS }} \quad$ System Inputs Setup Before TCK Low ${ }^{1}$ | 7 |  | 7 |  | ns |
| $\mathrm{t}_{\text {HSYs }} \quad$ System Inputs Hold After TCK Low ${ }^{1}$ | 18 |  | 18.5 |  | ns |
| $\mathrm{t}_{\text {TRSTW }} \quad \overline{\text { TRST }}$ Pulsewidth | $4 \mathrm{t}_{\mathrm{CK}}$ |  | $4 t_{\text {CK }}$ |  | ns |
| Switching Characteristics: |  |  |  |  |  |
| $\mathrm{t}_{\text {DTDO }} \quad$ TDO Delay from TCK Low |  | 13 |  | 13 | ns |
| $\mathrm{t}_{\text {DSYs }} \quad$ System Outputs Delay After TCK Low ${ }^{2}$ |  | 18.5 |  | 18.5 | ns |

## NOTES

${ }^{1}$ System Inputs $=\mathrm{DATA}_{47-0}, \mathrm{ADDR}_{31-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \mathrm{ACK}, \overline{\mathrm{SBTS}}, \overline{\mathrm{SW}}, \overline{\mathrm{HBR}}, \overline{\mathrm{HBG}}, \overline{\mathrm{CS}}, \overline{\mathrm{DMAR1}}, \overline{\mathrm{DMAR}}, \overline{\mathrm{BR}}{ }_{6-1}, \mathrm{ID}_{2-0}, \mathrm{RPBA}, \overline{\mathrm{IRQ}}_{2-0}, \mathrm{FLAG}_{3-0}, \mathrm{DR} 0, \mathrm{DR1}$, TCLK0, TCLK1, RCLK0, RCLK1, TFS0, TFS1, RFS0, RFS1, LxDAT ${ }_{3-0}$, LxCLK, LxACK, EBOOT, LBOOT, $\overline{\text { BMS }}$, CLKIN, $\overline{\text { RESET. }}$
${ }^{2}$ System Outputs $=\mathrm{DATA}_{47-0}, \mathrm{ADDR}_{31-0}, \overline{\mathrm{MS}}_{3-0}, \overline{\mathrm{RD}}, \overline{\mathrm{WR}}, \mathrm{ACK}$, PAGE, ADRCLK, $\overline{\mathrm{SW}}, \overline{\mathrm{HBG}}$, REDY, $\overline{\mathrm{DMAG1}}, \overline{\mathrm{DMAG} 2}, \overline{\mathrm{BR}} 6-\overline{\mathrm{CPA}}, \mathrm{FLAG}_{3-0}$, TIMEXP, DT0, DT1, TCLK0, TCLK1, RCLK0, RCLK1, TFS0, TFS1, RFS0, RFS1, LxDAT $_{3-0}$, LxCLK, LxACK, BMS.


Figure 24. IEEE 11499.1 JTAG Test Access Port

## ADSP-21062/ADSP-21062L

## OUTPUT DRIVE CURRENTS

Figure 28 shows typical I-V characteristics for the output drivers of the ADSP-21062. The curves represent the current drive capability of the output drivers as a function of output voltage.

## POWER DISSIPATION

Total power dissipation has two components, one due to internal circuitry and one due to the switching of external output drivers. Internal power dissipation is dependent on the instruction execution sequence and the data operands involved. Internal power dissipation is calculated in the following way:

$$
P_{I N T}=I_{D D I N} \times V_{D D}
$$

The external component of total power dissipation is caused by the switching of output pins. Its magnitude depends on:

- the number of output pins that switch during each cycle (O)
- the maximum frequency at which they can switch (f)
- their load capacitance (C)
- their voltage swing ( $\mathrm{V}_{\mathrm{DD}}$ )
and is calculated by:

$$
P_{E X T}=O \times C \times V_{D D}^{2} \times f
$$

The load capacitance should include the processor's package capacitance ( $\mathrm{C}_{\mathrm{IN}}$ ). The switching frequency includes driving the load high and then back low. Address and data pins can drive high and low at a maximum rate of $1 /\left(2 \mathrm{t}_{\mathrm{CK}}\right)$. The write strobe can switch every cycle at a frequency of $1 / \mathrm{t}_{\mathrm{CK}}$. Select pins switch at $1 /\left(2 \mathrm{t}_{\mathrm{CK}}\right)$, but selects can switch on each cycle.

## Example:

Estimate $\mathrm{P}_{\mathrm{EXT}}$ with the following assumptions:
-A system with one bank of external data memory RAM (32-bit)
-Four $128 \mathrm{~K} \times 8$ RAM chips are used, each with a load of 10 pF
-External data memory writes occur every other cycle, a rate of $1 /\left(4 \mathrm{t}_{\mathrm{CK}}\right)$, with $50 \%$ of the pins switching
-The instruction cycle rate is $40 \mathrm{MHz}\left(\mathrm{t}_{\mathrm{CK}}=25 \mathrm{~ns}\right)$.
The $\mathrm{P}_{\text {EXT }}$ equation is calculated for each class of pins that can drive:

Table II. External Power Calculations (5 V Device)

| Pin <br> Type | \# of <br> Pins | \% <br> Switching | $\times \mathbf{C}$ | $\times \mathbf{f}$ | $\times \mathbf{V}_{\text {DD }}{ }^{2}$ | $=\mathbf{P}_{\text {EXT }}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Address | 15 | 50 | $\times 44.7 \mathrm{pF}$ | $\times 10 \mathrm{MHz}$ | $\times 25 \mathrm{~V}$ | $=0.084 \mathrm{~W}$ |
| $\overline{\mathrm{MS} 0}$ | 1 | 0 | $\times 44.7 \mathrm{pF}$ | $\times 10 \mathrm{MHz}$ | $\times 25 \mathrm{~V}$ | $=0.000 \mathrm{~W}$ |
| $\overline{\mathrm{WR}}$ | 1 | - | $\times 44.7 \mathrm{pF}$ | $\times 20 \mathrm{MHz}$ | $\times 25 \mathrm{~V}$ | $=0.022 \mathrm{~W}$ |
| Data | 32 | 50 | $\times 14.7 \mathrm{pF}$ | $\times 10 \mathrm{MHz}$ | $\times 25 \mathrm{~V}$ | $=0.059 \mathrm{~W}$ |
| ADDRCLK | 1 | - | $\times 4.7 \mathrm{pF}$ | $\times 20 \mathrm{MHz}$ | $\times 25 \mathrm{~V}$ | $=0.002 \mathrm{~W}$ |

$$
\mathrm{P}_{\mathrm{EXT}}=0.167 \mathrm{~W}
$$

Table III. External Power Calculations (3.3 V Device)

| Pin <br> Type | \# of <br> Pins | \% <br> Switching | $\times \mathbf{C}$ | $\times \mathbf{f}$ | $\times \mathbf{V}_{\text {DD }}{ }^{2}$ | $=\mathbf{P}_{\text {EXT }}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Address | 15 | 50 | $\times 44.7 \mathrm{pF}$ | $\times 10 \mathrm{MHz}$ | $\times 10.9 \mathrm{~V}$ | $=0.037 \mathrm{~W}$ |
| $\overline{\mathrm{MS} 0}$ | 1 | 0 | $\times 44.7 \mathrm{pF}$ | $\times 10 \mathrm{MHz}$ | $\times 10.9 \mathrm{~V}$ | $=0.000 \mathrm{~W}$ |
| $\overline{\mathrm{WR}}$ | 1 | - | $\times 44.7 \mathrm{pF}$ | $\times 20 \mathrm{MHz}$ | $\times 10.9 \mathrm{~V}$ | $=0.010 \mathrm{~W}$ |
| Data | 32 | 50 | $\times 14.7 \mathrm{pF}$ | $\times 10 \mathrm{MHz}$ | $\times 10.9 \mathrm{~V}$ | $=0.026 \mathrm{~W}$ |
| ADDRCLK | 1 | - | $\times 4.7 \mathrm{pF}$ | $\times 20 \mathrm{MHz}$ | $\times 10.9 \mathrm{~V}$ | $=0.001 \mathrm{~W}$ |

A typical power consumption can now be calculated for these conditions by adding a typical internal power dissipation:

$$
P_{T O T A L}=P_{E X T}+\left(I_{D D I N 2} \times 5.0 \mathrm{~V}\right)
$$

Note that the conditions causing a worst-case $P_{\text {EXT }}$ are different from those causing a worst-case $\mathrm{P}_{\text {INT }}$. Maximum $\mathrm{P}_{\text {INT }}$ cannot occur while $100 \%$ of the output pins are switching from all ones to all zeros. Note also that it is not common for an application to have $100 \%$ or even $50 \%$ of the outputs switching simultaneously.

## TEST CONDITIONS

## Output Disable Time

Output pins are considered to be disabled when they stop driving, go into a high impedance state, and start to decay from their output high or low voltage. The time for the voltage on the bus to decay by $\Delta \mathrm{V}$ is dependent on the capacitive load, $\mathrm{C}_{\mathrm{L}}$ and the load current, $\mathrm{I}_{\mathrm{L}}$. This decay time can be approximated by the following equation:

$$
t_{D E C A Y}=\frac{C_{L} \Delta V}{I_{L}}
$$

The output disable time $\mathrm{t}_{\text {DIS }}$ is the difference between $\mathrm{t}_{\text {MEASURED }}$ and $t_{\text {decay }}$ as shown in Figure 25. The time $t_{\text {measured }}$ is the interval from when the reference signal switches to when the output voltage decays $\Delta \mathrm{V}$ from the measured output high or output low voltage. $\mathrm{t}_{\text {DECAY }}$ is calculated with test loads $\mathrm{C}_{\mathrm{L}}$ and $\mathrm{I}_{\mathrm{L}}$, and with $\Delta \mathrm{V}$ equal to 0.5 V .

## Output Enable Time

Output pins are considered to be enabled when they have made a transition from a high impedance state to when they start driving. The output enable time $t_{\text {ENA }}$ is the interval from when a reference signal reaches a high or low voltage level to when the output has reached a specified high or low trip point, as shown in the Output Enable/Disable diagram (Figure 25). If multiple pins (such as the data bus) are enabled, the measurement value is that of the first pin to start driving.

## Example System Hold Time Calculation

To determine the data output hold time in a particular system, first calculate $t_{\text {DECAY }}$ using the equation given above. Choose $\Delta \mathrm{V}$ to be the difference between the ADSP-21062's output voltage and the input threshold for the device requiring the hold time. A typical $\Delta \mathrm{V}$ will be $0.4 \mathrm{~V} . \mathrm{C}_{\mathrm{L}}$ is the total bus capacitance (per data line), and $\mathrm{I}_{\mathrm{L}}$ is the total leakage or three-state current (per data line). The hold time will be $t_{\text {DECAY }}$ plus the minimum disable time (i.e., $\mathrm{t}_{\mathrm{DATRWH}}$ for the write cycle).


Figure 25. Output Enable/Disable


Figure 26. Equivalent Device Loading for AC Measurements (Includes All Fixtures)

## Capacitive Loading

Output delays and holds are based on standard capacitive loads: 50 pF on all pins (see Figure 26). The delay and hold specifications given should be derated by a factor of $1.5 \mathrm{~ns} / 50 \mathrm{pF}$ for loads other than the nominal value of 50 pF . Figures 29-30, 33-34 show how output rise time varies with capacitance. Figures 31,35 show graphically how output delays and holds vary with load capacitance. (Note that this graph or derating does not apply to output disable delays; see the previous section Output Disable Time under Test Conditions.) The graphs of Figures 29, 30 and 31 may not be linear outside the ranges shown.


Figure 27. Voltage Reference Levels for AC Measurements (Except Output Enable/Disable)

ADSP-21062/ADSP-21062L


Figure 28. ADSP-21062 Typical Drive Currents $\left(V_{D D}=5 \mathrm{~V}\right)$


Figure 29. Typical Output Rise Time (10\%-90\% V VD) vs. Load Capacitance (VD $=5 \mathrm{~V}$ )


Figure 30. Typical Output Rise Time ( $0.8 \mathrm{~V}-2.0 \mathrm{~V}$ ) vs. Load Capacitance ( $V_{D D}=5 \mathrm{~V}$ )


Figure 31. Typical Output Delay or Hold vs. Load Capacitance (at Maximum Case Temperature) ( $V_{D D}=5 \mathrm{~V}$ )


Figure 32. ADSP-21062 Typical Drive Currents ( $V_{D D}=3.3$ V)


Figure 33. Typical Output Rise Time (10\%-90\% V $V_{D D}$ ) vs. Load Capacitance (VD $=3.3 \mathrm{~V}$ )


Figure 34. Typical Output Rise Time ( $0.8 \mathrm{~V}-2.0 \mathrm{~V}$ ) vs. Load Capacitance ( $V_{D D}=3.3 \mathrm{~V}$ )


Figure 35. Typical Output Delay or Hold vs. Load Capacitance (at Maximum Case Temperature) ( $V_{D D}=3.3 \mathrm{~V}$ )

## ENVIRONMENTAL CONDITIONS

## Thermal Characteristics

The ADSP-21062 is available in 240-lead thermally enhanced MQFP and 225-lead plastic ball grid array packages. The top surface of the thermally enhanced MQFP contains a copper slug from which most of the die heat is dissipated. The slug is flush with the top surface of the package. Note that the copper slug is internally connected to GND through the device substrate.
Both packages are specified for a case temperature ( $\mathrm{T}_{\mathrm{CASE}}$ ). To ensure that the $\mathrm{T}_{\text {CASE }}$ is not exceeded, a heatsink and/or an air flow source may be used. A heatsink should be attached with a thermal adhesive.

$$
T_{C A S E}=T_{A M B}+\left(P D \times \theta_{C A}\right)
$$

$T_{\text {CASE }}=$ Case temperature (measured on top surface of package) $P D=\quad$ Power dissipation in $W$ (this value depends upon the specific application; a method for calculating $P D$ is shown under Power Dissipation).
$\theta_{C A}=$ Value from table below.
240 MQFP

| $\boldsymbol{\theta}_{\text {JC }}=\mathbf{0 . 3}$ <br>  <br> Airflow <br> (Linear Ft./Min.) <br> $\mathbf{0}$ | $\mathbf{1 0 0}$ | $\mathbf{2 0 0}$ | $\mathbf{4 0 0}$ | $\mathbf{6 0 0}$ |  |
| :--- | :--- | :--- | :--- | :--- | :--- |
| $\theta_{\mathrm{CA}}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right)$ | 10 | 9 | 8 | 7 | 6 |

NOTES
This represents thermal resistance at total power of 5 W .
With air flow, no variance is seen in $\theta_{\mathrm{CA}}$ with power.
$\theta_{\mathrm{CA}}$ at 0 LFM varies with power: at $2 \mathrm{~W}, \theta_{\mathrm{CA}}=14^{\circ} \mathrm{C} / \mathrm{W}$, at $3 \mathrm{~W} \theta_{\mathrm{CA}}=11^{\circ} \mathrm{C} / \mathrm{W}$.
225 PBGA

| $\boldsymbol{\theta}_{\text {JC }}=1.7^{\circ} \mathrm{C} / \mathrm{W}$ <br> Airflow <br> (Linear Ft./Min.) | $\mathbf{0}$ | $\mathbf{2 0 0}$ | $\mathbf{4 0 0}$ |
| :--- | :--- | :--- | :--- |
| $\theta_{\mathrm{CA}}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right)$ | 20.7 | 15.3 | 12.9 |

NOTE
No variance is seen in $\theta_{\mathrm{CA}}$ with power.

ADSP-21062/ADSP-21062L
225-Ball Plastic Ball Grid Array (PBGA) Package Descriptions

| Ball \# | Name | Ball \# | Name | Ball \# | Name | Ball \# | Name | Ball \# | Name |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A01 | $\overline{\text { BMS }}$ | D01 | ADDR25 | G01 | ADDR14 | K01 | ADDR6 | N01 | $\overline{\text { EMU }}$ |
| A02 | ADDR30 | D02 | ADDR26 | G02 | ADDR15 | K02 | ADDR5 | N02 | TDO |
| A03 | DMAR2 | D03 | $\overline{\text { MS2 }}$ | G03 | ADDR16 | K03 | ADDR3 | N03 | $\overline{\text { IRQ0 }}$ |
| A04 | DT1 | D04 | ADDR29 | G04 | ADDR19 | K04 | ADDR0 | N04 | $\overline{\text { IRQ1 }}$ |
| A05 | RCLK1 | D05 | DMAR1 | G05 | GND | K05 | ICSA | N05 | ID2 |
| A06 | TCLK0 | D06 | TFS1 | G06 | VDD | K06 | GND | N06 | L5DAT1 |
| A07 | RCLK0 | D07 | $\overline{\mathrm{CPA}}$ | G07 | VDD | K07 | VDD | N07 | L4CLK |
| A08 | ADRCLK | D08 | $\overline{\text { HBG }}$ | G08 | VDD | K08 | VDD | N08 | L3CLK |
| A09 | $\overline{\mathrm{CS}}$ | D09 | $\overline{\text { DMAG2 }}$ | G09 | VDD | K09 | VDD | N09 | L3DAT3 |
| A10 | CLKIN | D10 | BR5 | G10 | VDD | K10 | GND | N10 | L2DAT0 |
| A11 | PAGE | D11 | $\overline{\mathrm{BR} 1}$ | G11 | GND | K11 | GND | N11 | L1ACK |
| A12 | $\overline{\text { BR3 }}$ | D12 | DATA40 | G12 | DATA22 | K12 | DATA8 | N12 | L1DAT3 |
| A13 | DATA47 | D13 | DATA37 | G13 | DATA25 | K13 | DATA11 | N13 | L0DAT3 |
| A14 | DATA44 | D14 | DATA35 | G14 | DATA24 | K14 | DATA13 | N14 | DATA1 |
| A15 | DATA42 | D15 | DATA34 | G15 | DATA23 | K15 | DATA14 | N15 | DATA3 |
| B01 | $\overline{\text { MS0 }}$ | E01 | ADDR21 | H01 | ADDR12 | L01 | ADDR2 | P01 | TRST |
| B02 | SW | E02 | ADDR22 | H02 | ADDR11 | L02 | ADDR1 | P02 | TMS |
| B03 | ADDR31 | E03 | ADDR24 | H03 | ADDR13 | LA03 | FLAG0 | P03 | EBOOT |
| B04 | HBR | E04 | ADDR27 | H04 | ADDR10 | L04 | FLAG3 | P04 | ID0 |
| B05 | DR1 | E05 | GND | H05 | GND | L05 | RPBA | P05 | L5CLK |
| B06 | DT0 | E06 | GND | H06 | VDD | L06 | GND | P06 | L5DAT3 |
| B07 | DR0 | E07 | GND | H07 | VDD | L07 | GND | P07 | L4DAT0 |
| B08 | REDY | E08 | GND | H08 | VDD | L08 | GND | P08 | L4DAT3 |
| B09 | $\overline{\mathrm{RD}}$ | E09 | GND | H09 | VDD | L09 | GND | P09 | L3DAT2 |
| B10 | ACK | E10 | GND | H10 | VDD | L10 | GND | P10 | L2CLK |
| B11 | BR6 | E11 | NC | H11 | GND | L11 | NC | P11 | L2DAT2 |
| B12 | $\overline{\mathrm{BR} 2}$ | E12 | DATA33 | H12 | DATA18 | L12 | DATA4 | P12 | L1DAT0 |
| B13 | DATA45 | E13 | DATA30 | H13 | DATA19 | L13 | DATA7 | P13 | L0ACK |
| B14 | DATA43 | E14 | DATA32 | H14 | DATA21 | L14 | DATA9 | P14 | L0DAT1 |
| B15 | DATA39 | E15 | DATA31 | H15 | DATA20 | L15 | DATA10 | P15 | DATA0 |
| C01 | $\overline{\text { MS3 }}$ | F01 | ADDR17 | J01 | ADDR9 | M01 | FLAG1 | R01 | TCK |
| C02 | $\overline{\text { MS1 }}$ | F02 | ADDR18 | J02 | ADDR8 | M02 | FLAG2 | R02 | $\overline{\text { IRQ2 }}$ |
| C 03 | $\underline{\text { ADDR } 28 ~}$ | F03 | ADDR20 | J03 | ADDR7 | M03 | TIMEXP | R03 | RESET |
| C04 | $\overline{\text { SBTS }}$ | F04 | ADDR23 | J04 | ADDR4 | M04 | TDI | R04 | ID1 |
| C 05 | TCLK1 | F05 | GND | J05 | GND | M05 | LBOOT | R05 | L5DAT0 |
| C06 | RFS1 | F06 | GND | J06 | VDD | M06 | L5ACK | R06 | L4ACK |
| C07 | TFS0 | F07 | VDD | J07 | VDD | M07 | L5DAT2 | R07 | L4DAT1 |
| C08 | RFS0 | F08 | VDD | J08 | VDD | M08 | L4DAT2 | R08 | L3ACK |
| C09 | WR | F09 | VDD | J09 | VDD | M09 | L3DAT0 | R09 | L3DAT1 |
| C10 | $\overline{\text { DMAG1 }}$ | F10 | GND | J10 | VDD | M10 | L2DAT3 | R10 | L2ACK |
| C11 | $\overline{\mathrm{BR4}}$ | F11 | GND | J11 | GND | M11 | L1DAT1 | R11 | L2DAT1 |
| C12 | DATA46 | F12 | DATA29 | J12 | DATA12 | M12 | L0DAT0 | R12 | L1CLK |
| C13 | DATA41 | F13 | DATA26 | J13 | DATA15 | M13 | DATA2 | R13 | L1DAT2 |
| C14 | DATA38 | F14 | DATA28 | J14 | DATA16 | M14 | DATA5 | R14 | L0CLK |
| C15 | DATA36 | F15 | DATA27 | J15 | DATA17 | M15 | DATA6 | R15 | L0DAT2 |

## 225-Ball Plastic Ball Grid Array (PBGA) Package Pinout

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DATA42 | DATA44 | DATA47 | $\overline{\text { BR3 }}$ | PAGE | CLKIN | $\overline{\text { CS }}$ | ADRCLK | RCLK0 | TCLKO | RCLK1 | DT1 | $\overline{\text { DMAR2 }}$ | ADDR30 | $\overline{\text { BMS }}$ |
| DATA39 | DATA43 | DATA45 | $\overline{\text { BR2 }}$ | $\overline{\text { BR6 }}$ | ACK | $\overline{\mathrm{RD}}$ | REDY | DR0 | DTO | DR1 | HBR | ADDR31 | sw | MSO |
| DATA36 | DATA38 | DATA41 | DATA46 | $\overline{\text { BR4 }}$ | $\overline{\text { DMAG1 }}$ | $\overline{\mathrm{WR}}$ | RFSO | TFSO | RFS1 | TCLK1 | $\overline{\text { SBTS }}$ | ADDR28 | $\overline{\text { MS1 }}$ | $\overline{\text { MS3 }}$ |
| DATA34 | DATA35 | DATA37 | DATA40 | $\overline{\text { BR1 }}$ | $\overline{\text { BR5 }}$ | $\overline{\text { DMAG2 }}$ | $\overline{\text { HBG }}$ | $\overline{\text { CPA }}$ | TFS1 | $\overline{\text { DMAR1 }}$ | ADDR29 | $\overline{\mathrm{MS}}$ | ADDR26 | ADDR25 |
| DATA31 | DATA32 | DATA30 | DATA33 | NC | GND | GND | GND | GND | GND | GND | ADDR27 | ADDR24 | ADDR22 | ADDR21 |
| DATA27 | DATA28 | DATA26 | DATA29 | GND | GND | VDD | VDD | VDD | GND | GND | ADDR23 | ADDR20 | ADDR18 | ADDR17 |
| DATA23 | DATA24 | DATA25 | DATA22 | GND | VDD | VDD | VDD | VDD | VDD | GND | ADDR19 | ADDR16 | ADDR15 | ADDR14 |
| DATA20 | DATA21 | DATA19 | DATA18 | GND | VDD | VDD | VDD | VDD | VDD | GND | ADDR10 | ADDR13 | ADDR11 | ADDR12 |
| DATA17 | DATA16 | DATA15 | DATA12 | GND | vDD | vDD | vDD | VDD | vDD | GND | ADDR4 | ADDR7 | ADDR8 | ADDR9 |
| DATA14 | DATA13 | DATA11 | DATA8 | GND | GND | VDD | VDD | VDD | GND | ICSA | ADDR0 | ADDR3 | ADDR5 | ADDR6 |
| DATA10 | DATA9 | DATA7 | DATA4 | NC | GND | GND | GND | GND | GND | RPBA | FLAG3 | FLAGO | ADDR1 | ADDR2 |
| DATA6 | DATA5 | DATA2 | LODATO | L1DAT1 | L2DAT3 | L3DATO | L4DAT2 | L5DAT2 | L5ACK | LBOOT | TDI | TIMEXP | FLAG2 | FLAG1 |
| DATA3 | DATA1 | LODAT3 | L1DAT3 | L1ACK | L2DATO | L3DAT3 | L3CLK | L4CLK | L5DAT1 | ID2 | $\overline{\text { IRQ1 }}$ | $\overline{\text { IRQO }}$ | TDO | EMU |
| DATAO | LODAT1 | LOACK | L1DAT0 | L2DAT2 | L2CLK | L3DAT2 | L4DAT3 | L4DATO | L5DAT3 | L5CLK | IDO | EBOOT | TMS | $\overline{\text { TRST }}$ |
| LODAT2 | LOCLK | L1DAT2 | L1CLK | L2DAT1 | L2ACK | L3DAT1 | L3ACK | L4DAT1 | L4ACK | L5DAT0 | ID1 | RESET | $\overline{\text { IRQ2 }}$ | TCK |

OUTLINE DIMENSIONS
Dimensions shown in inches and (mm).

## 225-Ball PBGA



240-LEAD METRIC MQFP PIN CONFIGURATIONS


THE 240-LEAD PACKAGE CONTAINS A COPPER HEAT SLUG FLUSH WITH ITS TOP SURFACE. THE SLUG IS INTERNALLY CONNECTED TO GROUND.

| Pin <br> No. | Pin <br> Name | Pin <br> No. | Pin <br> Name | $\begin{aligned} & \hline \text { Pin } \\ & \text { No. } \\ & \hline \end{aligned}$ | Pin <br> Name | Pin <br> No. | Pin <br> Name | $\begin{aligned} & \text { Pin } \\ & \text { No. } \end{aligned}$ | Pin Name |  | Pin Name |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | TDI | 41 | ADDR20 | 81 | TCLK0 | 121 | DATA41 | 161 | DATA14 | 20 | L2DAT0 |
| 2 | TRST | 42 | ADDR21 | 82 | TFS0 | 122 | DATA40 | 162 | DATA13 | 202 | L2CLK |
| 3 | VDD | 43 | GND | 83 | DR0 | 123 | DATA39 | 163 | DATA12 | 203 | L2ACK |
| 4 | TDO | 44 | ADDR22 | 84 | RCLK0 | 124 | VDD | 164 | GND | 20 | NC |
| 5 | TIMEXP | 45 | ADDR23 | 85 | RFS0 | 125 | DATA38 | 165 | DATA11 | 205 | VDD |
| 6 | EMU | 46 | ADDR24 | 86 | VDD | 126 | DATA37 | 166 | DATA10 | 206 | L3DAT3 |
| 7 | ICSA | 47 | VDD | 87 | VDD | 127 | DATA36 | 167 | DATA9 | 207 | L3DAT2 |
| 8 | FLAG3 | 48 | GND | 88 | GND | 128 | GND | 168 | VDD | 208 | L3DAT1 |
| 9 | FLAG2 | 49 | VDD | 89 | ADRCLK | 129 | NC | 169 | DATA8 | 209 | L3DAT0 |
| 10 | FLAG1 | 50 | ADDR25 | 90 | REDY | 130 | DATA35 | 170 | DATA7 | 210 | L3CLK |
| 11 | FLAG0 | 51 | ADDR26 | 91 | $\overline{\text { HBG }}$ | 131 | DATA34 | 171 | DATA6 | 21 | L3ACK |
| 12 | GND | 52 | ADDR27 | 92 | $\overline{\mathrm{CS}}$ | 132 | DATA33 | 172 | GND | 212 | GND |
| 13 | ADDR0 | 53 | GND | 93 | $\overline{\mathrm{RD}}$ | 133 | VDD | 173 | DATA5 | 21 | L4DAT3 |
| 14 | ADDR1 | 54 | MS3 | 94 | WR | 134 | VDD | 174 | DATA4 | 21 | L4DAT2 |
| 15 | VDD | 55 | MS2 | 95 | GND | 135 | GND | 175 | DATA3 | 215 | L4DAT1 |
| 16 | ADDR2 | 56 | MS1 | 96 | VDD | 136 | DATA32 | 176 | VDD | 21 | L4DAT0 |
| 17 | ADDR3 | 57 | MS 0 | 97 | GND | 137 | DATA31 | 177 | DATA2 | 21 | L4CLK |
| 18 | ADDR4 | 58 | SW | 98 | CLKIN | 138 | DATA30 | 178 | DATA1 | 218 | L4ACK |
| 19 | GND | 59 | BMS | 99 | ACK | 139 | GND | 179 | DATA0 | 219 | VDD |
| 20 | ADDR5 | 60 | ADDR28 | 100 | $\overline{\text { DMAG2 }}$ | 140 | DATA29 | 180 | GND | 22 | GND |
| 21 | ADDR6 | 61 | GND | 101 | DMAG1 | 141 | DATA28 | 181 | GND | 22 | VDD |
| 22 | ADDR7 | 62 | VDD | 102 | PAGE | 142 | DATA27 | 182 | L0DAT3 | 22 | L5DAT3 |
| 23 | VDD | 63 | VDD | 103 | VDD | 143 | VDD | 183 | L0DAT2 | 22 | L5DAT2 |
| 24 | ADDR8 | 64 | ADDR29 | 104 | BR6 | 144 | VDD | 184 | L0DAT1 | 22 | L5DAT1 |
| 25 | ADDR9 | 65 | ADDR30 | 105 | BR5 | 145 | DATA26 | 185 | L0DAT0 | 22 | L5DAT0 |
| 26 | ADDR10 | 66 | ADDR31 | 106 | $\overline{\text { BR4 }}$ | 146 | DATA25 | 186 | L0CLK | 22 | L5CLK |
| 27 | GND | 67 | GND | 107 | BR3 | 147 | DATA24 | 187 | L0ACK | 22 | L5ACK |
| 28 | ADDR11 | 68 | SBTS | 108 | BR2 | 148 | GND | 188 | VDD | 228 | GND |
| 29 | ADDR12 | 69 | $\overline{\text { DMAR2 }}$ | 109 | BR1 | 149 | DATA23 | 189 | L1DAT3 | 22 | ID2 |
| 30 | ADDR13 | 70 | DMAR1 | 110 | GND | 150 | DATA22 | 190 | L1DAT2 | 230 | ID1 |
| 31 | VDD | 71 | HBR | 111 | VDD | 151 | DATA21 | 191 | L1DAT1 | 23 | ID0 |
| 32 | ADDR14 | 72 | DT1 | 112 | GND | 152 | VDD | 192 | L1DAT0 | 23 | LBOOT |
| 33 | ADDR15 | 73 | TCLK1 | 113 | DATA47 | 153 | DATA20 | 193 | L1CLK | 23 | RPBA |
| 34 | GND | 74 | TFS1 | 114 | DATA46 | 154 | DATA19 | 194 | L1ACK | 23 | RESET |
| 35 | ADDR16 | 75 | DR1 | 115 | DATA45 | 155 | DATA18 | 195 | GND | 235 | EBOOT |
| 36 | ADDR17 | 76 | RCLK1 | 116 | VDD | 156 | GND | 196 | GND | 236 | IRQ2 |
| 37 | ADDR18 | 77 | RFS1 | 117 | DATA44 | 157 | DATA17 | 197 | VDD | 23 | $\overline{\text { IRQ1 }}$ |
| 38 | VDD | 78 | GND | 118 | DATA43 | 158 | DATA16 | 198 | L2DAT3 | 238 | $\overline{\text { IRQ0 }}$ |
| 39 | VDD | 79 | $\overline{\mathrm{CPA}}$ | 119 | DATA42 | 159 | DATA15 | 199 | L2DAT2 | 239 | TCK |
| 40 | ADDR19 | 80 | DT0 | 120 | GND | 160 | VDD | 200 | L2DAT1 | 24 | TMS |

OUTLINE DIMENSIONS
Dimensions shown in inches and (mm).
240-Lead Metric MQFP


ORDERING GUIDE

| Part Number | Case <br> Temperature Range | Instruction <br> Rate | On-Chip <br> SRAM | Operating <br> Voltage | Package <br> Options |
| :--- | :--- | :--- | :--- | :--- | :--- |
| ADSP-21062KS-133 | $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 33 MHz | 2 Mbit | 5 V | MQFP |
| ADSP-21062KS-160 | $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 40 MHz | 2 Mbit | 5 V | MQFP |
| ADSP-21062KB-160 | $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 40 MHz | 2 Mbit | 5 V | PBGA |
| ADSP-21062CS-160 | $-40^{\circ} \mathrm{C}$ to $+100^{\circ} \mathrm{C}$ | 40 MHz | 2 Mbit | 5 V | MQFP |
| ADSP-21062LKS-133 | $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 33 MHz | 2 Mbit | 3.3 V | MQFP |
| ADSP-21062LKS-160 | $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 40 MHz | 2 Mbit | 3.3 V | MQFP |
| ADSP-21062LKB-160 | $0^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 40 MHz | 2 Mbit | 3.3 V | PBGA |
| ADSP-21062LAB-160 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 40 MHz | 2 Mbit | 3.3 V | PBGA |
| ADSP-21062LCS-160 | $-40^{\circ} \mathrm{C}$ to $+100^{\circ} \mathrm{C}$ | 40 MHz | 2 Mbit | 3.3 V | MQFP |


[^0]:    Information furnished by Analog Devices is believed to be accurate and reliable. However, no responsibility is assumed by Analog Devices for its use, nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Analog Devices.

[^1]:    CBug and SHARCPAC are trademarks of Analog Devices, Inc. EZ-LAB is a registered trademark of Analog Devices, Inc.

[^2]:    $\mathrm{W}=$ (number of wait states specified in WAIT register) $\times \mathrm{t}_{\mathrm{CK}}$
    $\mathrm{HI}=\mathrm{t}_{\mathrm{CK}}$ (if an address hold cycle or bus idle cycle occurs, as specified in WAIT register; otherwise $\mathrm{HI}=0$ ).
    NOTES
    ${ }^{1}$ Only required for recognition in the current cycle.
    ${ }^{2} \mathrm{t}_{\text {SDATDGL }}$ is the data setup requirement if $\overline{\overline{D M A R}} \mathrm{x}$ is not being used to hold off completion of a write. Otherwise, if $\overline{\mathrm{DMAR}} \mathrm{x}$ low holds off completion of the write, the data can be driven $t_{\text {DATDRH }}$ after DMARx is brought high.
    ${ }^{3} \mathrm{t}_{\text {VDATDGH }}$ is valid if $\overline{\text { DMARx }}$ is not being used to hold off completion of a read. If $\overline{\text { DMAR }} \mathrm{x}$ is used to prolong the read, then $\mathrm{t}_{\text {VDATDGH }}=8+9 \mathrm{DT} / 16+\left(\mathrm{n} \times \mathrm{t}_{\mathrm{CK}}\right)$ where $n$ equals the number of extra cycles that the access is prolonged.
    ${ }^{4}$ See System Hold Time Calculation under Test Conditions for calculation of hold times given capacitive and dc loads.

[^3]:    NOTE
    ${ }^{1}$ LACK will go low with $t_{\text {DLALC }}$ relative to rising edge of LCLK after first nibble is received. LACK will not go low if the receiver's link buffer is not about to fill.

